

**TMAG5273** JAJSJS6B - JUNE 2021 - REVISED JULY 2024

# TMAG5273 I<sup>2</sup>C インターフェイス搭載、低消費電力、3 次元リニア ホール効果 センサ

# 1 特長

- 次のような電力モードを構成可能:
  - 2.3mA アクティブ モード電流
  - 1µA のウェークアップおよびスリープ モード電流
  - 5nA のスリープ モード電流
- X、Y、Z 軸で線形磁気感度範囲を選択可能:
  - TMAG5273x1:±40mT、±80mT
  - TMAG5273x2:±133mT, ±266mT
- ユーザー定義の磁気および温度スレッショルド通過か らの割り込み信号
- 感度ドリフト 5% (標準値)
- ゲインおよびオフセット調整付き角度 CORDIC 計算 機能を内蔵
- 20kSPS の1軸変換レート
- ノイズ除去用に最大 32 個の平均化を設定可能
- I<sup>2</sup>C または専用 INT ピンによる変換トリガ
- 巡回冗長検査 (CRC) 機能を持つ I<sup>2</sup>C インターフェイ スを最適化:
  - 最大 1MHz の I<sup>2</sup>C クロック速度
  - 特別な I<sup>2</sup>C フレーム読み取りによりスループット向 Ŀ.
  - I<sup>2</sup>C アドレスは出荷時にプログラム済み、また、ユー ザー設定も可能
- 各種磁石タイプに対応する温度補償機能を内蔵
- 温度センサ内蔵
- 1.7V~3.6V 電源電圧 V<sub>CC</sub> 範囲
- 動作温度範囲:-40℃~+125℃

# 2 アプリケーション

- 電気メーター
- 電子スマートロック
- スマートサーモスタット
- ジョイスティックとゲーム用コントローラ
- ドローンのペイロード制御
- ドアセンサおよび窓センサ
- 磁気近接センサ
- 移動型ロボットのモーター制御
- 電動自転車

### 3 概要

TMAG5273 は、幅広い産業用およびパーソナル エレクト ロニクス アプリケーション向けに設計された低消費電力 3 次元リニア ホール効果センサです。このデバイスは X、 Y、Z軸に3つの独立したホール効果センサを内蔵してい ます。高精度アナログ信号チェーンと内蔵 12 ビット A/D コンバータにより、磁界のアナログ測定値をデジタル値に 変換します。 I<sup>2</sup>C インターフェイスは、多様な動作 V<sub>CC</sub> 範 囲に対応すると同時に、低電圧マイクロコントローラとのシ ームレスなデータ通信を確保します。このデバイスには温 度センサが内蔵されており、特定の磁界における熱履歴 の確認または温度補償の計算など、各種システム機能に 利用できます。

TMAG5273 は I<sup>2</sup>C インターフェイスを通じて構成でき、磁 気軸と温度測定を組み合わせて使用できます。さらに、こ のデバイスは各種の電力オプション (ウェークアップおよび スリープ モードを含む) に構成できるため、設計者はシス テムレベルのニーズに基づいてシステムの消費電力を最 適化できます。複数のセンサ変換方式と I<sup>2</sup>C 読み出しフ レームにより、スループットと精度を最適化できます。低消 費電力のウェークアップおよびスリープ モード時に、専用 の INT ピンはシステム割り込みとして機能でき、マイクロコ ントローラによって新しいセンサ変換をトリガすることもでき ます。

内蔵の角度計算エンジン (CORDIC) は、軸上と軸外の両 方の角度測定トポロジについて、360°の角度位置情報を 提供します。角度の計算は、ユーザーが選択した 2 つの 磁気軸を使用して行います。このデバイスは磁気ゲインと オフセット補正機能を搭載しており、システムの機械的誤 差の原因による影響を緩和します。



(2)

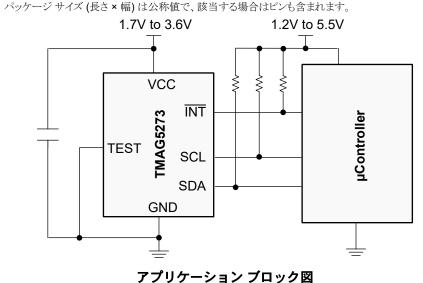


TMAG5273 は、出荷時にプログラムされた 4 つの異なる I<sup>2</sup>C アドレスで供給されます。また、このデバイスは、ユーザーが構成可能な I<sup>2</sup>C アドレス レジスタを変更することにより、追加の I<sup>2</sup>C アドレスにも対応できます。各発注用部品は、シス テム キャリブレーション時の磁石の強さおよび部品の配置に適した 2 つの磁界範囲のうちの 1 つを選択するように構成 できます。

このデバイスは、-40℃~+125℃の広い周囲温度範囲で正常に動作します。

| 部品番号     | パッケージ          | パッケージ サイズ <sup>(2)</sup> |  |  |  |
|----------|----------------|--------------------------|--|--|--|
| TMAG5273 | DBV (SOT-23、6) | 2.9mm × 2.8mm            |  |  |  |

(1) 利用可能なパッケージについては、データシートの末尾にあるパッケージオプションについての付録を参照してください。



パッケージ情報 (1)



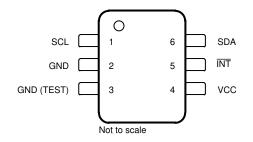
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# **4** Pin Configuration and Functions



### 図 4-1. DBV Package, 6-Pin SOT-23 (Top View)

### 表 4-1. Pin Functions

| PI         | N   | ТҮРЕ         | DESCRIPTION   |  |
|------------|-----|--------------|---|--|
| NAME       | NO. |              | DESCRIPTION   |  |
| SCL        | 1   | IO           | Serial clock.   |  |
| GND        | 2   | Ground       | Ground reference.   |  |
| GND (TEST) | 3   | Input        | TI Test Pin. Connect to ground in application.                                    |  |
| VCC        | 4   | Power supply | Power supply.   |  |
| INT        | 5   | Ю            | Interrupt input/ output. If not used and connected to ground, set MASK_INTB = 1b. |  |
| SDA        | 6   | IO           | Serial data.  |  |



### **5** Specifications

### 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|                  |                              | MIN  | MAX       | UNIT |
|------------------|------------------------------|------|-----------|------|
| V <sub>CC</sub>  | Main supply voltage          | -0.3 | 4         | V    |
| I <sub>OUT</sub> | Output current, SDA, INT     | 0    | 10        | mA   |
| V <sub>OUT</sub> | Output voltage, SDA, INT     | -0.3 | 7         | V    |
| V <sub>IN</sub>  | Input voltage, SCL, SDA, INT | -0.3 | 7         | V    |
| B <sub>MAX</sub> | Magnetic flux density        |      | Unlimited | Т    |
| TJ               | Junction temperature         | -40  | 150       | °C   |
| T <sub>stg</sub> | Storage temperature          | -65  | 170       | °C   |

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

### 5.2 ESD Ratings

|                    |                         |   | VALUE | UNIT |
|--------------------|-------------------------|---|-------|------|
| V                  | Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/<br>JEDEC JS-001, all pins <sup>(1)</sup>     | ±2000 | V    |
| V <sub>(ESD)</sub> | Electrostatic discharge | Charged device model (CDM), per JEDEC specification JS-002, all pins <sup>(2)</sup> | ±500  | V    |

(1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

### **5.3 Recommended Operating Conditions**

over operating free-air temperature range (unless otherwise noted) over recommended  $V_{CC}$  range (unless otherwise noted)

|                                  |                                   | MIN | NOM MAX | UNIT            |
|----------------------------------|-----------------------------------|-----|---------|-----------------|
| V <sub>CC</sub>                  | Main supply voltage               | 1.7 | 3.6     | V               |
| V <sub>OUT</sub>                 | Output voltage, SDA, INT          | 0   | 5.5     | V               |
| I <sub>OUT</sub>                 | Output current, SDA, INT          |     | 2       | mA              |
| V <sub>IH</sub>                  | Input HIGH voltage, SCL, SDA, INT | 0.7 |         | V <sub>CC</sub> |
| V <sub>IL</sub>                  | Input LOW voltage, SCL, SDA, INT  |     | 0.3     | V <sub>CC</sub> |
| $\Delta V_{CC} / \Delta t^{(1)}$ | Supply voltage ramp rate          | 3   |         | V/ms            |
| T <sub>A</sub>                   | Operating free air temperature    | -40 | 125     | °C              |

(1) If the VCC ramp rate is slower than the recommended supply voltage ramp rate, run a wake-up and sleep cycle after power-up or power-up reset to avoid I2C address glitch during sleep mode. This action is not required while operating in stand-by or continuous modes.



### **5.4 Thermal Information**

|  | TMAG5273   |  |
|--|--|--|
| THERMAL METRIC <sup>(1)</sup>                | DBV (SOT-23)   | UNIT   |
|  | 6 pins   |  |
| Junction-to-ambient thermal resistance       | 162  | °C/W   |
| Junction-to-case (top) thermal resistance    | 81.6   | °C/W   |
| Junction-to-board thermal resistance         | 50.1   | °C/W   |
| Junction-to-top characterization parameter   | 30.7   | °C/W   |
| Junction-to-board characterization parameter | 49.8   | °C/W   |
|  | Junction-to-ambient thermal resistance         Junction-to-case (top) thermal resistance         Junction-to-board thermal resistance         Junction-to-top characterization parameter | THERMAL METRIC <sup>(1)</sup> DBV (SOT-23)           6 pins         6 pins           Junction-to-ambient thermal resistance         162           Junction-to-case (top) thermal resistance         81.6           Junction-to-board thermal resistance         50.1           Junction-to-top characterization parameter         30.7 |

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application note.

### **5.5 Electrical Characteristics**

over operating free-air temperature range (unless otherwise noted)

over recommended V<sub>CC</sub> range (unless otherwise noted)

|                                  | PARAMETER                                     | TEST CONDITIONS   | MIN | TYP  | MAX  | UNIT |
|----------------------------------|---|---|-----|------|------|------|
| SDA, INT                         |   |   |     |      | •    |      |
| V <sub>OL</sub>                  | Output LOW voltage, SDA, INT pin              | I <sub>OUT</sub> = 2mA                                  | 0   |      | 0.4  | V    |
| I <sub>OZ</sub>                  | Output leakage current, SDA, INT pin          | Output disabled, V <sub>OZ</sub> = 5.5V                 |     |      | ±100 | nA   |
| t <sub>FALL_INT</sub>            | INT output fall time                          | $R_{PU}$ =10KΩ, $C_{L}$ =20pF, $V_{PU}$ =1.65V to 5.5V  |     | 6    |      | ns   |
| t <sub>INT (INT)</sub>           | INT Interrupt time duration during pulse mode | INT_MODE =001b or 010b                                  |     | 10   |      | μs   |
| t <sub>INT (SCL)</sub>           | SCL Interrupt time duration                   | INT_MODE =011b or 100b                                  |     | 10   |      | μs   |
| DC POWER S                       | ECTION  |   |     |      |      |      |
| VCC <sub>UV</sub> <sup>(1)</sup> | Undervoltage threshold at $V_{CC}$            | V <sub>CC</sub> = 2.3V to 3.6V                          | 1.9 | 2.0  | 2.2  | V    |
| IACTIVE                          | Active mode current                           | X, Y, Z, or thermal sensor active conversion, LP_LN =0b |     | 2.3  |      | mA   |
| IACTIVE                          | Active mode current                           | X, Y, Z, or thermal sensor active conversion, LP_LN =1b |     | 3.0  |      | mA   |
| ISTANDBY                         | Stand-by mode current                         | Device in trigger mode, no conversion started           |     | 0.45 |      | mA   |
| I <sub>SLEEP</sub>               | Sleep mode current                            |   |     | 5    |      | nA   |



# over operating free-air temperature range (unless otherwise noted) over recommended $V_{CC}$ range (unless otherwise noted)

|            | PARAMETER                            | TEST CONDITIONS  | MIN | TYP  | MAX | UNIT |
|------------|--------------------------------------|--|-----|------|-----|------|
| AVERAGE PC | OWER DURING WAKE-UP AND SLEEP (      | W&S) MODE  |     |      |     |      |
|            |                                      | Magnetic 1 channel conversion<br>V <sub>CC</sub> =3.3V |     | 160  |     | μA   |
|            | W&S mode current consumption         | Magnetic 1 channel conversion<br>V <sub>CC</sub> =1.8V |     | 156  |     | μA   |
|            | Wake-up interval 1ms<br>LP_LN =0b    | Magnetic 4 channel conversion<br>V <sub>CC</sub> =3.3V |     | 240  |     | μA   |
|            |                                      | Magnetic 4 channel conversion<br>V <sub>CC</sub> =1.8V |     | 233  |     | μA   |
| ICC_DCM    |                                      | Magnetic 1 channel conversion<br>V <sub>CC</sub> =3.3V |     | 1.21 |     | μA   |
|            | W&S mode current consumption         | Magnetic 1 channel conversion<br>V <sub>CC</sub> =1.8V |     | 1.00 |     | μΑ   |
|            | Wake-up interval 5000ms<br>LP_LN =0b | Magnetic 4 channel conversion<br>V <sub>CC</sub> =3.3V |     | 1.22 |     | μA   |
|            |                                      | Magnetic 4-channel conversion<br>V <sub>CC</sub> =1.8V |     | 1.02 |     | μA   |

(1) The DIAG\_STATUS and VCC\_UV\_ER bits are not valid for V<sub>CC</sub> < 2.3V

### 5.6 Temperature Sensor

over operating free-air temperature range (unless otherwise noted) over recommended  $V_{CC}$  range (unless otherwise noted)

|                         | PARAMETER   | TEST CONDITIONS | MIN | TYP   | MAX                  | UNIT   |
|-------------------------|---|-----------------|-----|-------|----------------------|--------|
| T <sub>SENS_RANGE</sub> | Temperature sensing range   |                 | -40 |       | 170 <mark>(1)</mark> | °C     |
| T <sub>ADC_T0</sub>     | Temperature result in decimal value (from 16-bit format) for T <sub>SENS_T0</sub> |                 |     | 17508 |                      |        |
| T <sub>SENS_T0</sub>    | Reference temperature for T <sub>ADC_T0</sub>                                     |                 |     | 25    |                      | °C     |
| T <sub>ADC_RES</sub>    | Temp sensing resolution (in 16-bit format)  |                 |     | 60.1  |                      | LSB/°C |
| NRMS_T                  | RMS (1 Sigma) temperature noise   | CONV_AVG = 000b |     | 0.4   |                      | °C     |
| NRMS_T                  | RMS (1 Sigma) temperature noise   | CONV_AVG = 101b |     | 0.2   |                      | °C     |

(1) TI recommends not to exceed the specified Operating free air temperature per Recommended Operating Conditions table



## 5.7 Magnetic Characteristics For A1, B1, C1, D1

### over operating free-air temperature range (unless otherwise noted)

|   | PARAMETER   | TEST CONDITIONS         | MIN TYP | MAX    | UNIT   |
|---|---|-------------------------|---------|--------|--------|
| D                                       | Lincor mognetic respective V V and Z              | _RANGE = 0b             | ±40     |        | mT     |
| B <sub>IN</sub>                         | Linear magnetic range for X, Y, and Z             | _RANGE = 1b             | ±80     |        | mT     |
| SENS                                    | Constituity X X or Z ovia                         | _RANGE = 0b, ±40mT      | 820     |        | LSB/mT |
| SENS                                    | Sensitivity, X, Y, or Z axis                      | _RANGE = 1b, ±80mT      | 410     |        | LSB/mT |
| SENS <sub>ER</sub>                      | Sensitivity error, X, Y, Z axis                   | T <sub>A</sub> = 25°C   | ±5.0%   | ±20.0% |        |
| SENS <sub>ER_DR</sub>                   | Sensitivity error drift from 25°C<br>X, Y, Z axis |                         | ±5.0%   |        |        |
|   | Sensitivity linearity error                       | X, Y Axis               | ±0.10%  | ±20.0% |        |
| SENS <sub>LER</sub> $T_A = 25^{\circ}C$ |   | Z Axis                  | ±0.10%  |        |        |
| SENS <sub>MS</sub> Sensitivity mismatch |   | X-Y axes                | ±0.50%  |        |        |
| SENS <sub>MS</sub>                      | $T_A = 25^{\circ}C$                               | Y-Z, or X-Z axes        | ±1.0%   |        |        |
|   |   | X-Y axes                | ±5%     |        |        |
| $SENS_{MS_DR}$                          | Sensitivity mismatch drift                        | Y-Z, or X-Z axes        | ±15%    |        |        |
| B <sub>off</sub>                        | Offset  | T <sub>A</sub> = 25°C   | ±300    | ±1000  | μT     |
| B <sub>off_TC</sub>                     | Offset drift                                      |                         | ±3.0    | ±10.0  | µT/°C  |
|   | RMS (1 Sigma) magnetic noise                      | LP_LN = 0b<br>X, Y Axis | 125     |        | μΤ     |
|   |   | LP_LN = 1b<br>X, Y Axis | 110     |        | μΤ     |
|   | RMS (1 Sigma) magnetic noise<br>CONV AVG = 101b   | LP_LN = 0b<br>X, Y Axis | 22      |        | μΤ     |
| N                                       | $T_A = 25^{\circ}C$                               | LP_LN = 1b<br>X, Y Axis | 22      |        | μΤ     |
| N <sub>RMS</sub>                        | RMS (1 Sigma) magnetic noise<br>CONV AVG = 000b   | LP_LN = 0b<br>Z Axis    | 68      |        | μΤ     |
|   | $T_A = 25^{\circ}C$                               | LP_LN = 1b<br>Z Axis    | 66      |        | μΤ     |
|   | RMS (1 Sigma) magnetic noise                      | LP_LN = 0b<br>Z Axis    | 11      |        | μT     |
|   | CONV_AVG = 101b<br>T <sub>A</sub> = 25°C          | LP_LN = 1b<br>Z Axis    | 9       |        | μT     |
|   | Angle error                                       | Y-Z                     | ±1.0    |        | Degree |
| A <sub>ERR</sub>                        | CONV_AVG = 101b                                   | X-Z                     | ±1.0    |        | Degree |
|   | T <sub>A</sub> = 25°C                             | X-Y                     | ±0.5    |        | Degree |



### 5.8 Magnetic Characteristics For A2, B2, C2, D2

over operating free-air temperature range (unless otherwise noted)

|                       | PARAMETER                                       |                         | MIN TYP | MAX    | UNIT   |  |
|-----------------------|---|-------------------------|---------|--------|--------|--|
| <b>D</b>              |   | _RANGE = 0b             | ±133    |        | mT     |  |
| B <sub>IN</sub>       | Linear magnetic range for X, Y, and Z           | _RANGE = 1b             | ±266    |        | mT     |  |
|                       |   | _RANGE = 0b, ±133mT     | 250     |        | LSB/mT |  |
| SENS                  | Sensitivity, X, Y, or Z axis                    | _RANGE = 0b, ±266mT     | 125     |        | LSB/mT |  |
| SENS <sub>ER</sub>    | Sensitivity error. X, Y, Z axis                 | T <sub>A</sub> = 25°C   | ±5.0%   | ±20.0% |        |  |
| SENS <sub>ER_DR</sub> | Sensitivity error drift. X, Y, Z axis           |                         | ±5.0%   |        |        |  |
| SENS                  | Sensitivity linearity error                     | X, Y Axis               | ±0.10%  |        |        |  |
| SENS <sub>LER</sub>   | T <sub>A</sub> = 25°C                           | Z Axis                  | ±0.10%  |        |        |  |
| SENS                  | Sensitivity mismatch                            | X-Y axes                | ±0.50%  |        |        |  |
| SENS <sub>MS</sub>    | $T_A = 25^{\circ}C$                             | Y-Z, or X-Z axes        | ±1.0%   |        |        |  |
| SENS                  | Sensitivity mismatch drift                      | X-Y axes                | ±5%     |        |        |  |
| $SENS_{MS_{DR}}$      |   | Y-Z, or X-Z axes        | ±15%    |        |        |  |
| B <sub>off</sub>      | Offset  | T <sub>A</sub> = 25°C   | ±300    | ±1000  | μT     |  |
| D <sub>off</sub>      | Offset drift                                    |                         | ±3.0    | ±10    | µT/°C  |  |
|                       | RMS (1 Sigma) magnetic noise<br>CONV AVG = 000b | LP_LN = 0b<br>X, Y Axis | 147     | 147    |        |  |
|                       | $T_A = 25^{\circ}C$                             | LP_LN = 1b<br>X, Y Axis | 145     |        | μΤ     |  |
|                       | RMS (1 Sigma) magnetic noise                    | LP_LN = 0b<br>X, Y Axis | 24      |        | μΤ     |  |
| N                     | CONV_AVG = 101b<br>T <sub>A</sub> = 25°C        | LP_LN = 1b<br>X, Y Axis | 24      |        | μΤ     |  |
| N <sub>RMS</sub>      | RMS (1 Sigma) magnetic noise                    | LP_LN = 0b<br>Z Axis    | 89      |        | μΤ     |  |
|                       | CONV_AVG = 000b<br>T <sub>A</sub> = 25°C        | LP_LN = 1b<br>Z Axis    | 88      |        | μΤ     |  |
|                       | RMS (1 Sigma) magnetic noise                    | LP_LN = 0b<br>Z Axis    | 15      |        | μΤ     |  |
|                       | CONV_AVG = 101b<br>T <sub>A</sub> = 25°C        | LP_LN = 1b<br>Z Axis    | 15      |        | μT     |  |
|                       | Angle error                                     | Y-Z                     | ±1.0    |        | Degree |  |
| A <sub>ERR</sub>      | CONV_AVG = 101b                                 | X-Z                     | ±1.0    |        | Degree |  |
|                       | T <sub>A</sub> = 25°C                           | X-Y                     | ±0.50   |        | Degree |  |

### **5.9 Magnetic Temp Compensation Characteristics**

over operating free-air temperature range (unless otherwise noted)

|       | PARAMETER                               | TEST CONDITIONS  | MIN | TYP  | MAX | UNIT |
|-------|---|------------------|-----|------|-----|------|
| TC_00 | Temperature compensation (X, Y, Z-axes) | MAG_TEMPCO = 00b |     | 0    |     | %/°C |
| TC_12 | Temperature compensation (X, Y, Z-axes) | MAG_TEMPCO = 01b |     | 0.12 |     | %/°C |
| TC_20 | Temperature compensation (X, Y, Z-axes) | MAG_TEMPCO = 11b |     | 0.2  |     | %/°C |



### 5.10 I2C Interface Timing

over operating free-air temperature range (unless otherwise noted)

|                        | PARAMETER                                      | TEST CONDITIONS                               | MIN  | TYP | MAX  | UNIT |
|------------------------|--|---|------|-----|------|------|
| I2C Interface          | Fast Mode Plus (V <sub>CC</sub> =2.3V to 3.6V) |   |      |     | 1    |      |
| f <sub>I2C_fmp</sub>   | I2C clock (SCL) frequency                      | LOAD = 50pF<br>V <sub>CC</sub> = 2.3V to 3.6V |      |     | 1000 | KHz  |
| t <sub>whigh_fmp</sub> | High time: SCL logic high time duration        |   | 350  |     |      | ns   |
| t <sub>wlo_wfmp</sub>  | Low time: SCL logic low time duration          |   | 500  |     |      | ns   |
| t <sub>su_cs_fmp</sub> | SDA data setup time                            |   | 50   |     |      | ns   |
| t <sub>h_cs_fmp</sub>  | SDA data hold time                             |   | 120  |     |      | ns   |
| t <sub>icr_fmp</sub>   | SDA, SCL input rise time                       |   |      |     | 120  | ns   |
| t <sub>icf_fmp</sub>   | SDA, SCL input fall time                       |   |      |     | 55   | ns   |
| t <sub>h_ST_fmp</sub>  | Start condition hold time                      |   | 0.1  |     |      | μs   |
| t <sub>su_SR_fmp</sub> | Repeated start condition setup time            |   | 0.1  |     |      | μs   |
| t <sub>su_SP_fmp</sub> | Stop condition setup time                      |   | 0.1  |     |      | μs   |
| tw_SP_SR_fmp           | Bus free time between stop and start condition |   | 0.2  |     |      | μs   |
| I2C Interface          | Fast Mode (V <sub>CC</sub> =1.7V to 3.6V)      |   |      |     | 1    |      |
| f <sub>I2C</sub>       | I2C clock (SCL) frequency                      | LOAD = 50pF<br>V <sub>CC</sub> = 1.7V to 3.6V |      |     | 400  | KHz  |
| t <sub>whigh</sub>     | High time: SCL logic high time duration        |   | 600  |     |      | ns   |
| t <sub>wlow</sub>      | Low time: SCL logic low time duration          |   | 1300 |     |      | ns   |
| t <sub>su_cs</sub>     | SDA data setup time                            |   | 100  |     |      | ns   |
| t <sub>h_cs</sub>      | SDA data hold time                             |   | 0    |     |      | ns   |
| t <sub>icr</sub>       | SDA, SCL input rise time                       |   |      |     | 300  | ns   |
| t <sub>icf</sub>       | SDA, SCL input fall time                       |   |      |     | 300  | ns   |
| t <sub>h_ST</sub>      | Start condition hold time                      |   | 0.3  |     |      | μs   |
| t <sub>su_SR</sub>     | Repeated start condition setup time            |   | 0.3  |     |      | μs   |
| t <sub>su_SP</sub>     | Stop condition setup time                      |   | 0.3  |     |      | μs   |
| t <sub>w_SP_SR</sub>   | Bus free time between stop and start condition |   | 0.6  |     |      | μs   |

### 5.11 Power up & Conversion Time

over operating free-air temperature range (unless otherwise noted)

|                             | PARAMETER   | TEST CONDITIONS                | MIN | TYP | MAX | UNIT |
|-----------------------------|---|--------------------------------|-----|-----|-----|------|
| t <sub>start_power_up</sub> | Time to go to standby mode after $V_{CC}$ supply voltage crossing $V_{CC\_MIN}$ |                                |     | 270 |     | μs   |
| t <sub>start_sleep</sub>    | Time to go from sleep mode to standby mode <sup>(1)</sup>                       |                                |     | 50  |     | μs   |
| t <sub>start_measure</sub>  | Time to go from standby mode to continuous measure mode                         |                                |     | 70  |     | μs   |
|                             | Conversion time   | CONV_AVG = 000b <sup>(2)</sup> |     | 50  |     | μs   |
| t <sub>measure</sub>        | Only one channel enabled<br>OPERATING_MODE = 10b                                | CONV_AVG = 101b <sup>(3)</sup> |     | 825 |     | μs   |
| t <sub>go_sleep</sub>       | Time to go into sleep mode after SCL goes high                                  |                                |     | 20  |     | μs   |

(1) The device only recognizes the I2C communication from a primary during standby or continuous measure modes. While the device is in sleep mode, a valid secondary address wakes up the device but no acknowledge is sent to the primary. Consider the start-up time before addressing the device after wake up.

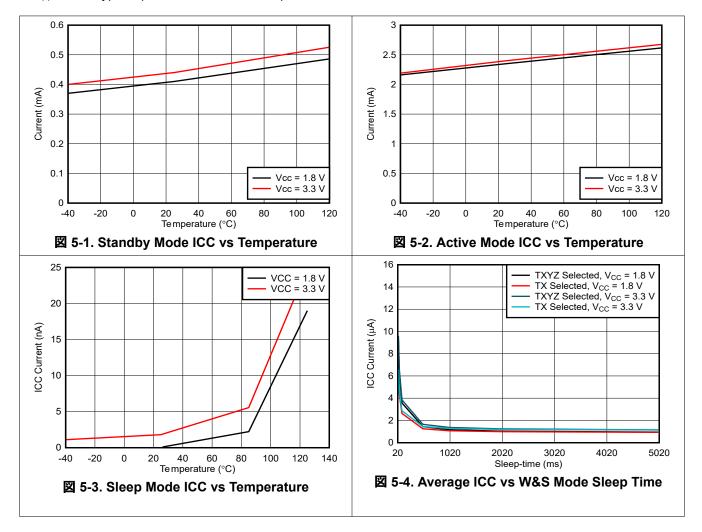
(2) Add 25µs for each additional magnetic channel enabled for conversion with CONV\_AVG = 000b. When CONV\_AVG = 000b, the conversion time doesn't change with the T\_CH\_EN bit setting.

(3) For conversion with CONV\_AVG =101b, each channel data is collected 32 times. If an additional channel is enabled with CONV\_AVG =101b, add 32×25µs = 800µs to the t<sub>measure</sub> to calculate the conversion time for two channels.



### **5.12 Typical Characteristics**

at T<sub>A</sub> = 25°C typical (unless otherwise noted)





### 6 Detailed Description

### 6.1 Overview

The TMAG5273 IC is based on the Hall-effect technology and precision mixed signal circuitry from Texas Instruments. The output signals (raw X, Y, Z magnetic data and temperature data) are accessible through the  $I^2C$  interface.

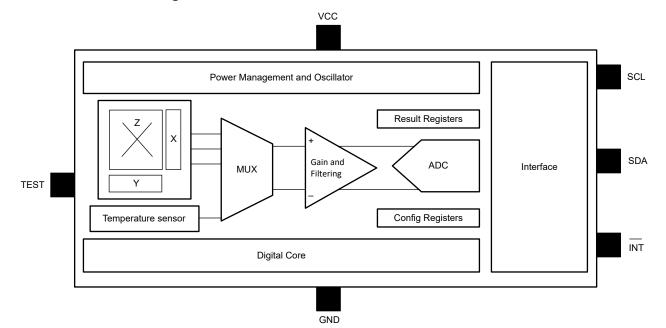
The IC consists of the following functional and building blocks:

• The Power Management & Oscillator block contains a low-power oscillator, biasing circuitry, undervoltage detection circuitry, and a fast oscillator.

• The sensing and temperature measurement block contains the Hall biasing, Hall sensors with multiplexers, noise filters, integrator circuit, temperature sensor, and the ADC. The Hall-effect sensor data and temperature data are multiplexed through the same ADC.

• The Interface block contains the I<sup>2</sup>C control circuitry, ESD protection circuits, and all the I/O circuits. The TMAG5273 supports multiple I<sup>2</sup>C read frames along with integrated cyclic redundancy check (CRC).

### 6.2 Functional Block Diagram

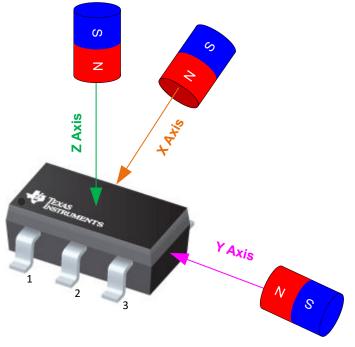




### 6.3 Feature Description

### 6.3.1 Magnetic Flux Direction

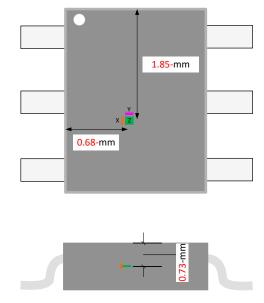
As shown in  $\boxtimes$  6-1, the TMAG5273 generates positive ADC codes in response to a magnetic north pole in proximity. Similarly, the TMAG5273 generates negative ADC codes if the magnetic south poles approach from the same directions.



☑ 6-1. Direction of Sensitivity

### 6.3.2 Sensor Location

☑ 6-2 shows the location of X, Y, Z hall elements inside the TMAG5273.



3 6-2. Location of X, Y, Z Hall Elements



### 6.3.3 Interrupt Function

The TMAG5273 supports flexible and configurable interrupt functions through either the  $\overline{INT}$  or the SCL pin.  $\overline{\pm}$  6-1 shows different conversion completion events where result registers and SET\_COUNT bits update, and where they do not.

| INT_MODE | MODE   | I <sup>2</sup> C BUS BUSY,<br>TO DEVICE | NOT TALKING          | I <sup>2</sup> C BUS BUSY<br>DEVICE | & TALKING TO         | I <sup>2</sup> C BUS NOT BUSY |                      |  |
|----------|--|---|----------------------|-------------------------------------|----------------------|-------------------------------|----------------------|--|
| INT_MODE | DESCRIPTION  | RESULT<br>UPDATE?                       | SET_COUNT<br>UPDATE? | RESULT<br>UPDATE?                   | SET_COUNT<br>UPDATE? | RESULT<br>UPDATE?             | SET_COUNT<br>UPDATE? |  |
| 000b     | No interrupt   | Yes                                     | Yes                  | No                                  | No                   | Yes                           | Yes                  |  |
| 001b     | Interrupt<br>through INT   | Yes                                     | Yes                  | No                                  | No                   | Yes                           | Yes                  |  |
| 010b     | Interrupt<br>through INT<br>except when<br>I <sup>2</sup> C busy | Yes                                     | Yes                  | No                                  | No                   | Yes                           | Yes                  |  |
| 011b     | Interrupt<br>through SCL   | Yes                                     | Yes                  | No                                  | No                   | Yes                           | Yes                  |  |
| 100b     | Interrupt<br>through SCL<br>except when<br>I <sup>2</sup> C busy | No                                      | No                   | No                                  | No                   | Yes                           | Yes                  |  |

表 6-1. Result Register & SET\_COUNT Update After Conversion Completion

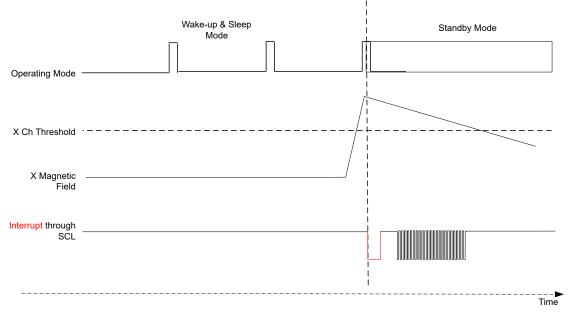
注

TI does not recommend sharing the same  $l^2C$  bus with multiple secondary devices when using the SCL pin for interrupt function. The SCL interrupt may corrupt transactions with other secondary devices if present in the same  $l^2C$  bus.

#### Interrupt Through SCL

 $\boxtimes$  6-3 shows an example for interrupt function through the SCL pin with the device programmed to wake up and sleep mode for threshold cross at a predefined intervals. The wake-up intervals can be set through the SLEEPTIME bits. When the device detects a magnetic threshold cross, the TMAG5273 asserts a fixed width interrupt signal through the SCL pin, and goes back to standby mode.





### 図 6-3. Interrupt Through SCL

### Fixed Width Interrupt Through INT

 $\boxtimes$  6-4 shows an example for fixed-width interrupt function through the  $\overline{INT}$  pin. The device is programmed to be in wake-up and sleep mode to detect a magnetic threshold. The INT\_STATE register bit is set 1b. When the device detects a magnetic threshold cross, the TMAG5273 asserts a fixed width interrupt signal through the  $\overline{INT}$  pin, and goes back to standby mode.

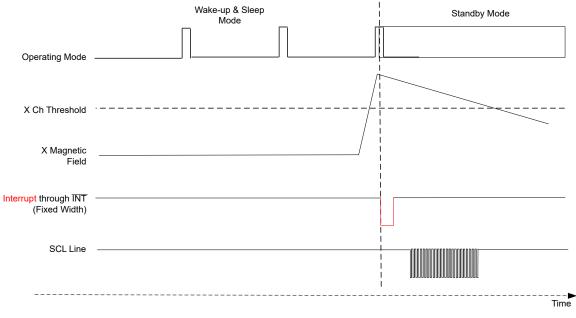


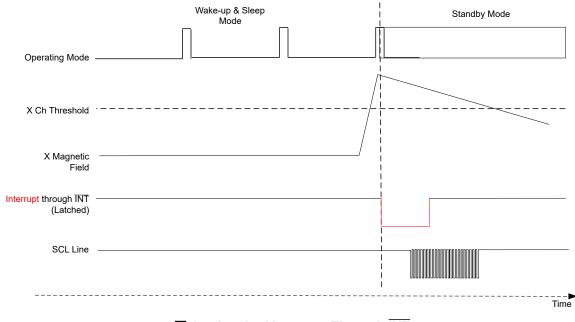
図 6-4. Fixed Width Interrupt Through INT

### Latched Interrupt Through INT

 $\boxtimes$  6-5 shows an example for latched interrupt function through the  $\overline{INT}$  pin. The device is programmed to be in wake-up and sleep mode to detect a magnetic threshold. The INT\_STATE register bit is set 0b. When the device



detects a magnetic threshold cross, the TMAG5273 asserts a latched interrupt signal through the INT pin and goes back to standby mode. The interrupt latch is cleared only after the device receives a valid address through the SCL line.



### ☑ 6-5. Latched Interrupt Through INT

### 6.3.4 Device I<sup>2</sup>C Address

 $\pm$  6-2 shows the default factory programmed I<sup>2</sup>C addresses of the TMAG5273. The device needs to be addressed with the factory default I<sup>2</sup>C address after power up. If required, a primary can assign a new I<sup>2</sup>C address through the I2C\_ADDRESS register bits after power up.

#### 表 6-2. I<sup>2</sup>C Default Address

| DEVICE VERSION | MAGNETIC<br>RANGE  | I <sup>2</sup> C ADDRESS (7 MSB BITS) | I <sup>2</sup> C WRITE ADDRESS (8-BIT) | I <sup>2</sup> C READ ADDRESS (8-<br>BIT) |
|----------------|--------------------|---------------------------------------|--|---|
| TMAG5273A1     |                    | 35h                                   | 6Ah                                    | 6Bh                                       |
| TMAG5273B1     | ±40 mT, ±80 mT     | 22h                                   | 44h                                    | 45h                                       |
| TMAG5273C1     |                    | 78h                                   | F0h                                    | F1h                                       |
| TMAG5273D1     |                    | 44h                                   | 88h                                    | 89h                                       |
| TMAG5273A2     |                    | 35h                                   | 6Ah                                    | 6Bh                                       |
| TMAG5273B2     | 122 mT 1266 mT     | 22h                                   | 44h                                    | 45h                                       |
| TMAG5273C2     | ±133 mT, ±266 mT - | 78h                                   | F0h                                    | F1h                                       |
| TMAG5273D2     |                    | 44h                                   | 88h                                    | 89h                                       |



### 6.3.5 Magnetic Range Selection

 $\pm$  6-3 shows the magnetic range selection for the TMAG5273 device. The X, Y, and Z axes range can be selected with the X\_Y\_RANGE and Z\_RANGE register bits.

|                 | RANGE REGISTER SETTING | TMAG5273A1 | TMAG5273A2 | COMMENT                |  |  |  |  |  |
|-----------------|------------------------|------------|------------|------------------------|--|--|--|--|--|
| X, Y Axis Field | X_Y_RANGE = 0b         | ±40-mT     | ±133-mT    |                        |  |  |  |  |  |
|                 | X_Y_RANGE = 1b         | ±80-mT     | ±266-mT    | Better SNR performance |  |  |  |  |  |
|                 | Z_RANGE = 0b           | ±40-mT     | ±133-mT    |                        |  |  |  |  |  |
|                 | Z_RANGE = 1b           | ±80-mT     | ±266-mT    | Better SNR performance |  |  |  |  |  |

表 6-3. Magnetic Range Selection

### 6.3.6 Update Rate Settings

The TMAG5273 offers multiple update rates to offer design flexibility to system designers. The different update rates can be selected with the CONV\_AVG register bits.  $\gtrsim$  6-4 shows different update rate settings for the TMAG5273.

| OPERATING    | REGISTER SETTING |             | COMMENT   |            |                     |
|--------------|------------------|-------------|-----------|------------|---------------------|
| MODE         | REGISTER SETTING | SINGLE AXIS | TWO AXES  | THREE AXES |                     |
| X, Y, Z Axis | CONV_AVG = 000b  | 20.0-kSPS   | 13.3-kSPS | 10.0-kSPS  | Fastest update rate |
| X, Y, Z Axis | CONV_AVG = 001b  | 13.3-kSPS   | 8.0-kSPS  | 5.7-kSPS   |                     |
| X, Y, Z Axis | CONV_AVG = 010b  | 8.0-kSPS    | 4.4-kSPS  | 3.1-kSPS   |                     |
| X, Y, Z Axis | CONV_AVG = 011b  | 4.4-kSPS    | 2.4-kSPS  | 1.6-kSPS   |                     |
| X, Y, Z Axis | CONV_AVG = 100b  | 2.4-kSPS    | 1.2-kSPS  | 0.8-kSPS   |                     |
| X, Y, Z Axis | CONV_AVG = 101b  | 1.2-kSPS    | 0.6-kSPS  | 0.4-kSPS   | Best SNR case       |

表 6-4. Update Rate Settings



### 6.4 Device Functional Modes

The TMAG5273 supports multiple functional modes for wide array of applications as explained in  $\boxtimes$  6-6. A specific functional mode is selected by setting the corresponding value in the OPERATING\_MODE register bits. The device starts powering up after VCC supply crosses the minimum threshold as specified in the Recommended Operating Condition (ROC) table.

### 6.4.1 Standby (Trigger) Mode

The TMAG5273 goes to standby mode after first time powering up. At this mode the digital circuitry and oscillators are on, and the device is ready to accept commands from the primary device. Based off the commands the device can start a sensor data conversion, go to power saving mode, or start data transfer through I<sup>2</sup>C interface. A new conversion can be triggered through I<sup>2</sup>C command or through INT pin. In this mode the device retains the immediate past conversion result data in the corresponding result registers. The time for the device to go from power up to standby mode is listed as  $T_{start_power_up}$  in the *Power up & Conversion Time* table.

#### 6.4.2 Sleep Mode

The TMAG5273 supports an ultra-low power sleep mode where the device retains the critical user configuration settings. The device does not retain the conversion result data in sleep mode. A primary can wake up the device from sleep mode through I<sup>2</sup>C interface or the  $\overline{INT}$  pin. During the transition from sleep mode to standby mode through I<sup>2</sup>C interface the  $\overline{INT}$  pin briefly asserts an interrupt. The  $\overline{INT}$  pin recovers after the device fully transitions to the standby mode with RESULT\_STATUS bit set to 0h indicating no conversion is completed. The time it takes for the device to go to standby mode from sleep mode is denoted by T<sub>start sleep</sub>.

#### 6.4.3 Wake-up and Sleep (W&S) Mode

In this mode the TMAG5273 can be configured to go to sleep and wake up at a certain interval, and measure sensor data based off the SLEEPTIME register bits setting. The device can be set to generate an interrupt through the INT\_CONFIG\_1 register. After the conversion is complete and the interrupt condition is met, the TMAG5273 exits the W&S mode and goes into standby mode. The last measured data is stored in the corresponding result registers before the device goes to the standby mode. If the interrupt condition is not met, the device continues in W&S mode to wake up and measure data at the specified interval. A primary can wake up the TMAG5273 anytime during the W&S mode through I<sup>2</sup>C bus or INT pin. The result interrupt function is not available during the W&S mode. The device to go from W&S mode to standby mode is listed as  $T_{start sleep}$  in the *Power up & Conversion Time* table.



#### 6.4.4 Continuous Measure Mode

In this mode the TMAG5273 continuously measures the sensor data per SENSOR\_CONFIG & DEVICE CONFIG register settings. In this mode the result registers can be accessed through the I2C lines. The time for the device to go from continuous measure mode to standby mode is listed as T<sub>start measure</sub> in the *Power* up & Conversion Time table.

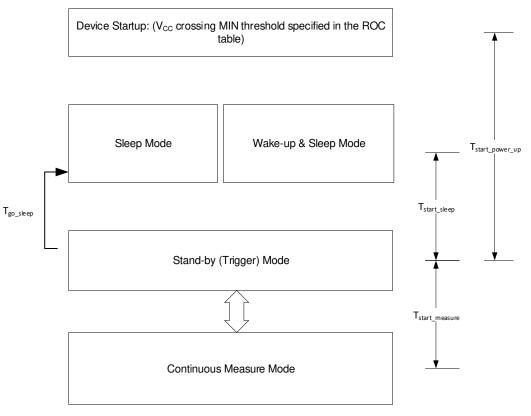


図 6-6. TMAG5273 Power-Up Sequence

 $\pm$  6-5 shows different device operational modes of the TMAG5273.

| 表 6-5. Operating Modes     |   |                                |                              |   |  |  |  |  |
|----------------------------|---|--------------------------------|------------------------------|---|--|--|--|--|
| OPERATING<br>MODE          | DEVICE FUNCTION   | ACCESS TO<br>USER<br>REGISTERS | RETAIN USER<br>CONFIGURATION | COMMENT   |  |  |  |  |
| Continuous<br>Measure Mode | Continuously measuring x, y, z axis, or temperature data                                  | Yes                            | Yes                          |   |  |  |  |  |
| Standby Mode               | Device is ready to accept I <sup>2</sup> C commands and start active conversion           | Yes                            | Yes                          |   |  |  |  |  |
| Wake-up and<br>Sleep Mode  | Wakes up at a certain interval to measure the x, y, z axis, or temperature data           | No                             | Yes                          | 1ms, 5ms, 10ms, 15ms, 20ms, 30ms,<br>50ms, 100ms, 500ms, 1000ms, 2000ms,<br>5000ms, and 20000ms intervals<br>supported.           |  |  |  |  |
| Sleep Mode                 | Device retains key configuration<br>settings, but does not retain the<br>measurement data | No                             | Yes                          | The primary device can use sleep mode<br>to implement other power saving intervals<br>not supported by wake-up and sleep<br>mode. |  |  |  |  |

| ŧ | 6-5  | One | rating | Mod | es |
|---|------|-----|--------|-----|----|
| × | U-J. | Obe | auny   | wou | 63 |



### 6.5 Programming

### 6.5.1 I<sup>2</sup>C Interface

The TMAG5273 offers I<sup>2</sup>C interface, a two-wire interface to connect low-speed devices like microcontrollers, A/D and D/A converters, I/O interfaces and other similar peripherals in embedded systems.

#### 6.5.1.1 SCL

The SCL is the clock line used to synchronize all data transfers over the I<sup>2</sup>C bus.

#### 6.5.1.2 SDA

SDA is the bidirectional data line for the  $I^2C$  interface.

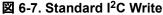
#### 6.5.1.3 I<sup>2</sup>C Read/Write

The TMAG5273 supports multiple I<sup>2</sup>C read and write frames targeting different applications. I2C\_RD and CRC\_EN bits offers multiple read frames to optimize the read time, data resolution and data integrity for a select application.

### 6.5.1.3.1 Standard I<sup>2</sup>C Write

 $\boxtimes$  6-7 shows an example of standard I<sup>2</sup>C two byte write command supported by TMAG5273. The starting byte contains 7-bit secondary device address and a 0 at the R/ $\boxtimes$  command bit. The MSB of the second byte contains the conversion trigger bit. Write 1 at this trigger bit to start a new conversion after the register address decoding is complete. The seven LSB bits of the second byte contains the starting register address for the write command. After the two command bytes, the primary device starts to send the data to be written at the corresponding register address. Each successive write byte sends the data for the successive register address in the secondary device.

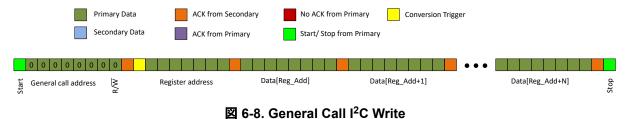




#### 6.5.1.3.2 General Call Write

20

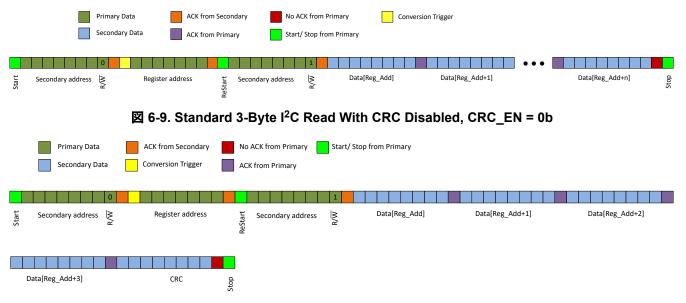
 $\boxtimes$  6-8 shows an example of the general call I<sup>2</sup>C write command supported by the TMAG5273. This command is useful to configure multiple I<sup>2</sup>C devices in a I<sup>2</sup>C bus simultaneously. The starting byte contains 8-bit 0s. The MSB of the second byte contains the conversion trigger bit. Write 1 at this trigger bit to start a new conversion after the register address decoding is completed. The seven LSB bits of the second byte contains the starting register address for the write command. After the two command bytes, the primary device starts to send the data to be written at the corresponding register address of all the secondary devices in the I<sup>2</sup>C bus. Each successive write byte sends the data for the successive register address in the secondary devices.

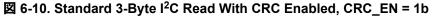




#### 6.5.1.3.3 Standard 3-Byte I<sup>2</sup>C Read

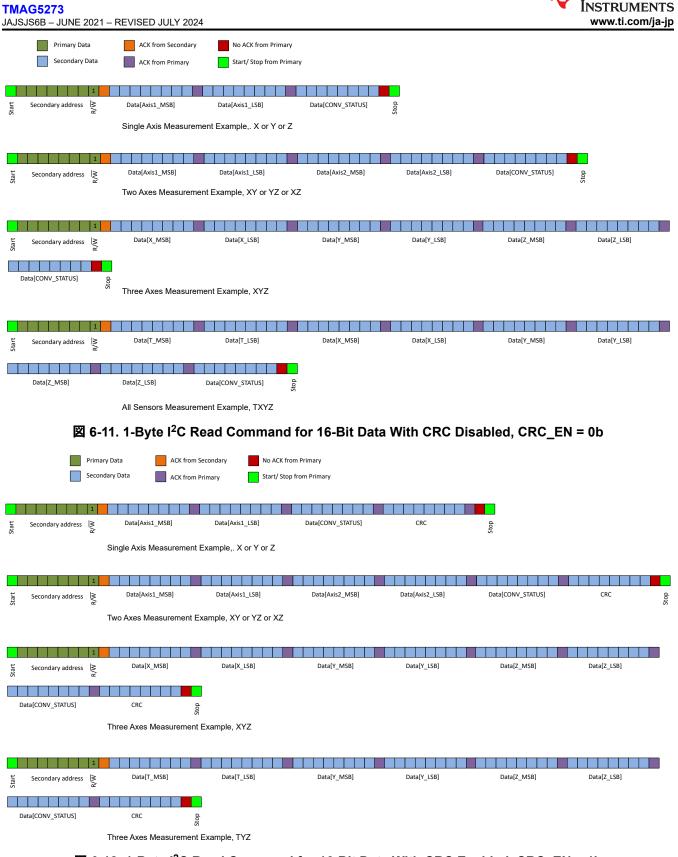
⊠ 6-9 and ⊠ 6-10 show examples of standard  $I^2C$  three byte read command supported by the TMAG5273. The starting byte contains 7-bit secondary device address and the R/W command bit 0. The MSB of the second byte contains the conversion trigger command bit. Write 1 at this trigger bit to start a new conversion after the register address decoding is completed. The seven LSB bits of the second byte contains the starting register address for the write command. After receiving ACK signal from secondary, the primary send the secondary address once again with R/W command bit as 1. The secondary starts to send the corresponding register data, and sends successive register data with each successive ACK from the primary. If CRC is enabled, the secondary sends the fifth CRC byte based off the CRC calculation of immediate past four register bytes.





#### 6.5.1.3.4 1-Byte I2C Read Command for 16-Bit Data

⊠ 6-11 and ⊠ 6-12 show examples of 1-byte  $I^2C$  read command supported by the TMAG5273. Select I2C\_RD =01b to enable this mode. The command byte contains 7-bit secondary device address and a 1 at the R/W bit. In this mode, per MAG\_CH\_EN and T\_CH\_EN bits setting, the device sends 16-bit data of the enabled channels and the CONV\_STATUS register data byte. If CRC is enabled, the device sends an additional CRC byte based off the CRC calculation of the command byte and the data sent in the current packet. When multiple channels are enabled, the sent data follows the T, X, Y, and Z sequence in the successive data bytes.



Texas



#### 6.5.1.3.5 1-Byte I<sup>2</sup>C Read Command for 8-Bit Data

⊠ 6-13 and ⊠ 6-14 show examples of 1-byte I<sup>2</sup>C read command supported by the TMAG5273. Select I2C\_RD =10b to enable this mode. The command byte contains 7-bit secondary device address and a 1 at the R/W bit. In this mode, per MAG\_CH\_EN and T\_CH\_EN bits setting, the device sends 8-bit data of the enabled channels and the CONV\_STATUS register data byte. If CRC is enabled, the device sends an additional CRC byte based off the CRC calculation of the command byte and the data sent in the current packet. When multiple channels are enabled, the sent data follows the T, X, Y, and Z sequence in the successive data bytes.

|       | Primary Data Secondary Data |          |               | n Secondar<br>n Primary | y        |            | from Primary |      |           |          |      |                   |         |                   |      |
|-------|-----------------------------|----------|---------------|-------------------------|----------|------------|--------------|------|-----------|----------|------|-------------------|---------|-------------------|------|
|       |                             |          |               |                         |          |            |              |      |           |          |      |                   |         |                   |      |
| Start | Secondary address           | R/W<br>T | Data[Axis     | 1_MSB]                  |          | Data[CON   | IV_STATUS]   | Stop |           |          |      |                   |         |                   |      |
|       |                             |          | Single Axis M | easurem                 | ent Exan | nple,. X o | or Y or Z    |      |           |          |      |                   |         |                   |      |
|       |                             | 1        |               |                         |          |            |              |      |           |          |      |                   |         |                   |      |
| Start | Secondary address           |          | Data[Axi      |                         |          |            | kis2_MSB]    |      | Data[CONV | _STATUS] | Stop |                   |         |                   |      |
|       |                             |          | Two Axes Mea  | asureme                 | nt Examp | ole, XY o  | r YZ or XZ   | 2    |           |          |      |                   |         |                   |      |
|       |                             | 1        |               |                         |          |            |              |      |           |          |      |                   |         |                   |      |
| Start | Secondary address           | R/W      | Data[X        | _MSB]                   |          | Data[Y_M   | ISB]         |      | Data[Z    | _MSB]    |      | Data[CONV_STATUS] | 40<br>5 |                   |      |
|       |                             |          | Three Axes M  | easurem                 | ent Exar | mple, XYZ  | Z            |      |           |          |      |                   |         |                   |      |
|       |                             | 1        |               |                         |          |            |              |      |           |          |      |                   |         |                   |      |
| Start | Secondary address           | R/W      | Data[T        | _MSB]                   |          | Data[X     | (_MSB]       |      | Data[Y_MS | B]       |      | Data[Z_MSB]       |         | Data[CONV_STATUS] | Stop |
|       |                             |          | All Sensors M | easurem                 | ent Exar | nple, TX   | YZ           |      |           |          |      |                   |         |                   |      |

図 6-13. 1-Byte I<sup>2</sup>C Read Command for 8-Bit Data With CRC Disabled, CRC\_EN = 0b

**TMAG5273** 

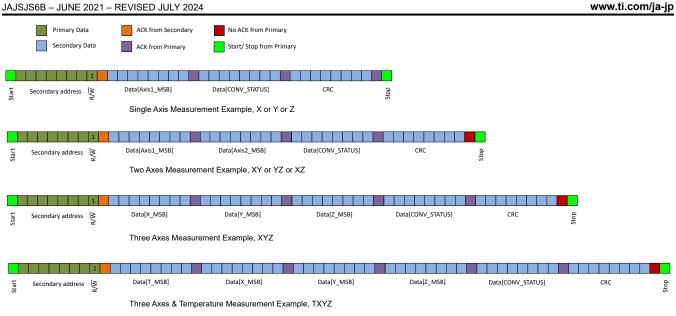


図 6-14. 1-Byte I<sup>2</sup>C Read Command for 8-Bit Data With CRC Enabled, CRC EN = 1b

注 In the 1-byte read command for 8-bit data any combinations of channels can be sent without restrictions.

### 6.5.1.3.6 I<sup>2</sup>C Read CRC

The TMAG5273 supports optional CRC during I<sup>2</sup>C read. The CRC can be enabled through the CRC EN register bit. The CRC is performed on a data string that is determined by the I<sup>2</sup>C read type. The CRC information is sent as a single byte after the data bytes. The code is generated by the polynomial  $x^8 + x^2 + x + 1$ . Initial CRC bits are FFh.

The following equations can be employed to calculate CRC:

| d = Data Input, c = Initial CRC (FFh)   | (1) |
|---|-----|
| newcrc[0] = d[7] ^ d[6] ^ d[0] ^ c[0] ^ c[6] ^ c[7]                           | (2) |
| newcrc[1] = d[6] ^ d[1] ^ d[0] ^ c[0] ^ c[1] ^ c[6]                           | (3) |
| newcrc[2] = d[6] ^ d[2] ^ d[1] ^ d[0] ^ c[0] ^ c[1] ^ c[2] ^ c[6]             | (4) |
| newcrc[3] = d[7] ^ d[3] ^ d[2] ^ d[1] ^ c[1] ^ c[2] ^ c[3] ^ c[7]             | (5) |
| newcrc[4] = d[4] ^ d[3] ^ d[2] ^ c[2] ^ c[3] ^ c[4]                           | (6) |
| newcrc[5] = d[5] ^ d[4] ^ d[3] ^ c[3] ^ c[4] ^ c[5]                           | (7) |
| newcrc[6] = d[6] ^ d[5] ^ d[4] ^ c[4] ^ c[5] ^ c[6]                           | (8) |
| newcrc[7] = d[7] ^ d[6] ^ d[5] ^ c[5] ^ c[6] ^ c[7]                           | (9) |
| The following examples show calculated CRC byte based off various input data: |     |
| I2C Data 00h : CRC = F3h  |     |

I2C Data FFh : CRC = 00h



I2C Data 80h : CRC = 7Ah

I2C Data 4Ch : CRC = 10h

I2C Data E0h : CRC = 5Dh

I2C Data 00000000h : CRC = D1h

I2C Data FFFFFFFh : CRC = 0Fh

### 6.5.2 Data Definition

### 6.5.2.1 Magnetic Sensor Data

The X, Y, and Z magnetic sensor data are stored in x\_MSB\_RESULT and x\_LSB\_RESULT registers.  $\boxtimes$  6-15 shows that each sensor output stored in a 16-bit 2's complement format in two 8-bit registers. The data can be retrieved as 16-bit format combining both MSB and LSB registers, or as 8-bit format through the MSB register.

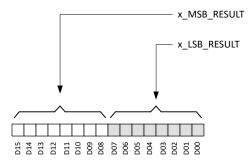


図 6-15. Magnetic Sensor Data Definition

The measured magnetic field can be calculated using 式 10 for 16-bit data, and using 式 11 for 8-bit data.

$$B = \frac{-(D_{15} \times 2^{15}) + \sum_{i=0}^{14} D_i \times 2^i}{2^{16}} \times 2|B_R|$$
(10)

where

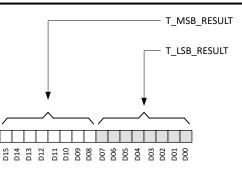
- B is magnetic field in mT.
- $D_i$  is the data bit shown in  $\boxtimes$  6-15.
- B<sub>R</sub> is the magnetic range in mT for the corresponding channel.

$$B = \frac{-(D_{15} \times 2^7) + \sum_{i=0}^{6} D_{i+8} \times 2^i}{2^8} \times 2|B_R|$$
(11)

### 6.5.2.2 Temperature Sensor Data

The TMAG5273 will measure temperature from -40 °C to 170 °C. The temperature sensor data are stored in T\_MSB\_RESULT and T\_LSB\_RESULT registers.  $\boxtimes$  6-16 shows the sensor output stored in a 16-bit 2's complement format in two 8-bit registers. The data can be retrieved as 16-bit format combining both MSB and LSB registers, or as 8-bit format through the MSB register.





### 6-16. Temperature Sensor Data Definition

The measured temperature in degree Celsius can be calculated using  $\pm$  12 for 16-bit data, and using  $\pm$  13 for 8-bit data.

$$T = T_{SENS_T0} + \frac{T_{ADC_T} - T_{ADC_T0}}{T_{ADC_RES}}$$
(12)

where

- T is the measured temperature in degree Celsius.
- T<sub>SENS T0</sub> as listed in the *Electrical Characteristics* table.
- T<sub>ADC RES</sub> is the change in ADC code per degree Celsius.
- T<sub>ADC T0</sub> as listed in the *Electrical Characteristics* table.
- T<sub>ADC T</sub> is the measured ADC code for temperature T.

$$T = T_{SENS_T0} + \frac{256 \times \left(T_{ADC_T} - \frac{T_{ADC_T0}}{256}\right)}{T_{ADC_RES}}$$
(13)

#### 6.5.2.3 Angle and Magnitude Data Definition

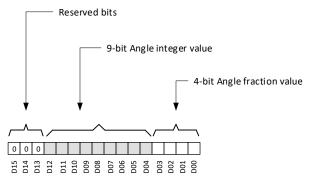
The TMAG5273 calculates the angle from a pair of magnetic axes based off the ANGLE\_EN register bits setting.  $\boxtimes$  6-17 shows the angle information stored in the ANGLE\_RESULT\_MSB and ANGLE\_RESULT\_LSB registers. Bits D04-D12 store angle integer value from 0 to 360 degree. Bits D00-D03 store fractional angle value. The 3-MSB bits are always populated as b000. The angle can be calculated using  $\neq$  14.

$$A = \sum_{i=4}^{12} D_i \times 2^{i-4} + \frac{\sum_{i=0}^{3} D_i \times 2^i}{16}$$
(14)

where

- A is the angle measured in degree.
- $D_i$  is the data bit as shown in 🗵 6-17.

For example: a 354.50 degree is populated as 0001 0110 0010 1000b and a 17.25 degree is populated as 000 0001 0001 0100b.



### 3 6-17. Angle Data Definition

During the angle calculation, use  $\neq$  15 to calculate the resultant vector magnitude.

$$M = \sqrt{MADC_{Ch1}^{2} + MADC_{Ch2}^{2}}$$
(15)

where

• MADC<sub>Ch1</sub>, MADC<sub>Ch2</sub> are the ADC codes of the two magnetic channels selected for the angle calculation.

⊠ 6-18 shows the magnitude value stored in the MAGNITUDE\_RESULT register. For on-axis angular measurement the magnitude value should remain constant across the full 360° measurement.

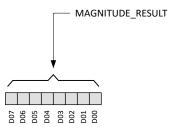


図 6-18. Magnitude Result Data Definition

#### 6.5.2.4 Magnetic Sensor Offset Correction

The TMAG5273 enables offset correction for a pair of magnetic axes (see  $\boxtimes$  6-19). The MAG\_OFFSET\_CONFIG\_1 and MAG\_OFFSET\_CONFIG\_2 registers store the offset values to be corrected in 2's complement data format. As an example, if the uncorrected waveform for a particular axis has a value that is +2mT too high, enter an offset correction value of -2mT in the corresponding offset correction register. The selection and order of the sensors are defined in the ANGLE\_EN register bits setting. The default value of these offset correction registers are set as zero.



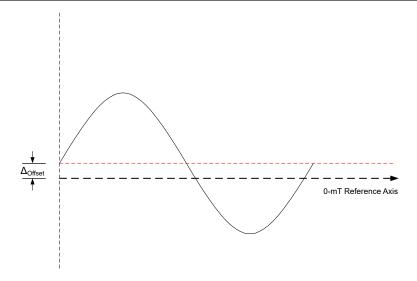


図 6-19. Magnetic Sensor Data Offset Correction

The amount of offset for each axis can be calculated using  $\neq$  16. As an example, with a ±40mT range, MAG\_OFFSET\_CONFIG\_1 set at 1000 0000b, and MAG\_OFFSET\_CONFIG\_2 set at 0001 0000b, the offset correction for the first axis is -2.5mT and second axis is 0.312mT.

$$\Delta_{\text{Offset}} = \frac{-(D_7 \times 2^7) + \sum_{i=0}^6 D_i \times 2^i}{2^{12}} \times 2|B_R|$$
(16)

where

- Δ<sub>Offset</sub> is the amount of offset correction to be applied in mT.
- D<sub>i</sub> is the data bit in the MAG\_OFFSET\_CONFIG\_1 or MAG\_OFFSET\_CONFIG\_2 register.
- B<sub>R</sub> is the magnetic range in mT for the corresponding channel.

Alternately values for MAG\_OFFSET\_CONFIG\_1 or MAG\_OFFSET\_CONFIG\_2 can be calculated for a target offset correction using 式 17.

$$MAG_OFFSET = \frac{2^{12} \times \Delta_{Offset}}{2|B_R|}$$
(17)

where

- MAG\_OFFSET is the decimal value to be entered in the MAG\_OFFSET\_CONFIG\_1 or MAG\_OFFSET\_CONFIG\_2 register.
- Δ<sub>Offset</sub> is the amount of offset correction to be applied in mT.
- B<sub>R</sub> is the magnetic range in mT for the corresponding channel.



### 7 Application and Implementation

注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 7.1 Application Information

### 7.1.1 Select the Sensitivity Option

Select the highest TMAG5273 sensitivity option that can measure the required range of magnetic flux density so that the ADC input range is maximized.

Larger-sized magnets and farther sensing distances can generally enable better positional accuracy than very small magnets at close distances, because magnetic flux density increases exponentially with the proximity to a magnet. TI created an online tool to help with simple magnet calculations under the TMAG5273 product folder on ti.com.

#### 7.1.2 Temperature Compensation for Magnets

The TMAG5273 temperature compensation is designed to directly compensate the average temperature drift of several magnets as specified in the MAG\_TEMPCO register bits. The residual induction ( $B_r$ ) of a magnet typically reduces by 0.12%/°C for NdFeB, and 0.20%/°C for ferrite magnets as the temperature increases. Set the MAG\_TEMPCO bit to default 00b if the device temperature compensation is not needed.

#### 7.1.3 Sensor Conversion

Multiple conversion schemes can be adopted based off the MAG\_CH\_EN and CONV\_AVG register bits settings.

#### 7.1.3.1 Continuous Conversion

The TMAG5273 can be set in continuous conversion mode when OPERATING\_MODE is set to 10b.  $\boxtimes$  7-1 shows few examples of continuous conversion. The input magnetic field is processed in two steps. In the first step the device spins the hall sensor elements, and integrates the sampled data. In the second step the ADC block converts the analog signal into digital bits and stores in the corresponding result register. While the ADC starts processing the first magnetic sample, the spin block can start processing another magnetic sample. In this mode the temperature data is taken at the beginning of each new conversion. This temperature data is used to compensate for the magnetic thermal drift.

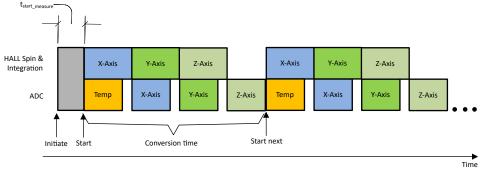
t<sub>start</sub> measu

HALL Spin &

Integration

ADC

Initiate Start



X-Axis

Temp

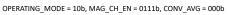
Start next

X-Axis

X-Axis

X-Axis

→ Time



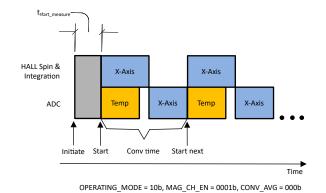
### 図 7-1. Continuous Conversion Examples

### 7.1.3.2 Trigger Conversion

The TMAG5273 supports trigger conversion with OPERATING\_MODE set to 00b. The trigger event can be initiated through I<sup>2</sup>C command or  $\overline{INT}$  signal.  $\boxtimes$  7-2 shows an example of trigger conversion with temperature, X, Y, and Z sensors activated.







X-Axis

X-Axis

Conv time

X-Axis

X-Axis

Temp



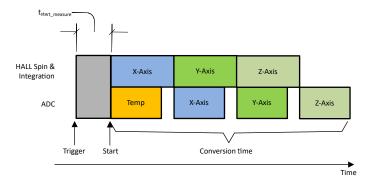


図 7-2. Trigger Conversion for Temperature, X, Y, & Z Sensors

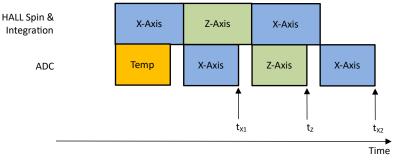
#### 7.1.3.3 Pseudo-Simultaneous Sampling

In absolute angle measurement, application sensor data from multiple axes are required to calculate an accurate angle. The magnetic field data collected at different times through the same signal chain introduces error in angle calculation. The TMAG5273 offers pseudo-simultaneous sampling data collection modes to eliminate this error.  $\boxtimes$  7-3 shows an example where MAG\_CH\_EN is set at 1011b to collect XZX data.  $\ddagger$  18 shows that the time stamps for the X and Z sensor data are the same.

$$t_{\rm Z} = \frac{t_{\rm X1} + t_{\rm X2}}{2} \tag{18}$$

### where

•  $t_{X1}$ ,  $t_Z$ ,  $t_{X2}$  are time stamps for X, Z, X sensor data completion as defined in  $\boxtimes$  7-3.



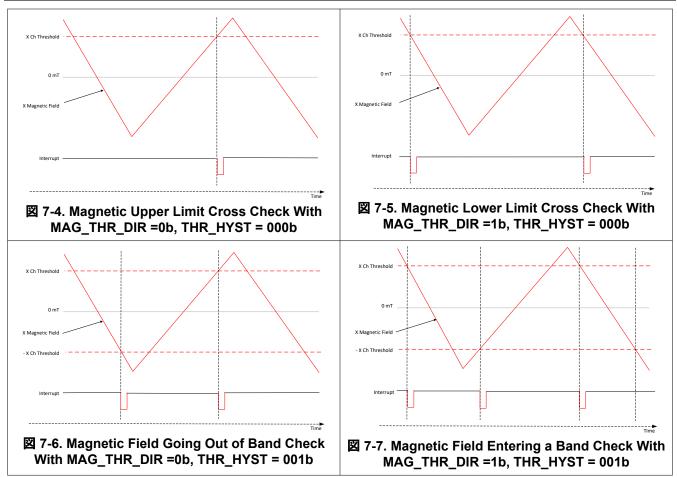


The vertical X, Y sensors of the TMAG5273 exhibit more noise than the horizontal Z sensor. The pseudosimultaneous sampling can be used to equalize the noise floor when two set of vertical sensor data are collected against one set of horizontal sensor data, as in examples of XZX or YZY modes.

### 7.1.4 Magnetic Limit Check

The TMAG5273 enables magnetic limit checks for single or multiple axes at the same time.  $\boxtimes$  7-4 to  $\boxtimes$  7-7 show examples of magnetic limit cross detection events while the field going above, below, exiting a magnetic band, and entering a magnetic band. The device generates an interrupt with each new conversion if the magnetic fields remain in the shaded regions of the figures. The MAG\_THR\_DIR and THR\_HYST register bits help select different limit cross modes.





### 7.1.5 Error Calculation During Linear Measurement

The TMAG5273 offers independent configurations to perform linear position measurements in X, Y, and Z axes. To calculate the expected error during linear measurement, the contributions from each of the individual error sources must be understood. The relevant error sources include sensitivity error, offset, noise, cross axis sensitivity, hysteresis, nonlinearity, drift across temperature, drift across life time, and so forth. For a 3-axis Hall sensor like the TMAG5273, the cross-axis sensitivity and hysteresis error sources are insignificant. Use  $\neq$  19 to estimate the linear measurement error calculation at room temperature.

$$\text{Error}_{\text{LM}_25\text{C}} = \frac{\sqrt{(B \times \text{SENS}_{\text{ER}})^2 + B_{\text{off}}^2 + N_{\text{RMS}_25}^2}}{B} \times 100\%$$
(19)

where

- Error<sub>LM 25C</sub> is total error in % during linear measurement at 25°C.
- B is input magnetic field.
- SENS<sub>ER</sub> is sensitivity error in decimal number at 25°C. As an example, enter 0.05 for sensitivity error of 5%.
- B<sub>off</sub> is offset error at 25°C.
- N<sub>RMS 25</sub> is RMS noise at 25°C.

In many applications, system level calibration at room temperature can nullify the offset and sensitivity errors at 25°C. The noise errors can be reduced by internally averaging by up to 32x on the device in addition to the averaging that can be done in the microcontroller. Use  $\gtrsim 20$  to estimate the linear measurement error across temperature after calibration at room temperature.



$$\operatorname{Error}_{\operatorname{LM}_{\operatorname{Temp}}} = \frac{\sqrt{(B \times \operatorname{SENS}_{\operatorname{DR}})^2 + B_{\operatorname{off}_{\operatorname{DR}}}^2 + N_{\operatorname{RMS}_{\operatorname{Temp}}}^2}}{B} \times 100\%$$
(20)

where

- Error<sub>LM\_Temp</sub> is total error in % during linear measurement across temperature after room temperature calibration.
- B is input magnetic field.
- SENS<sub>DR</sub> is sensitivity drift in decimal number from value at 25°C. As an example, enter 0.05 for sensitivity drift of 5%.
- B<sub>off DR</sub> is offset drift from value at 25°C.
- N<sub>RMS Temp</sub> is RMS noise across temperature.

If room temperature calibration is not performed, sensitivity and offset errors at room temperature must also account for total error calculation across temperature (see  $\neq$  21).

$$\operatorname{Error}_{\operatorname{LM}_{\operatorname{Temp}}\operatorname{NCal}} = \frac{\sqrt{(B \times \operatorname{SENS}_{\operatorname{ER}})^2 + (B \times \operatorname{SENS}_{\operatorname{DR}})^2 + B_{\operatorname{off}}^2 + B_{\operatorname{off}}^2 + B_{\operatorname{off}}^2 - R_{\operatorname{RMS}_{\operatorname{Temp}}}^2 \times 100\%}{B} \times 100\%$$
(21)

#### where

Error<sub>LM\_Temp\_NCal</sub> is total error in % during linear measurement across temperature without room temperature calibration.

注

In this section, error sources such as system mechanical vibration, magnet temperature gradient, earth magnetic field, nonlinearity, lifetime drift, and so forth, are not considered. The user must take these additional error sources into account while calculating overall system error budgets.

#### 7.1.6 Error Calculation During Angular Measurement

The TMAG5273 offers on-chip CORDIC to measure angle data from any of the two magnetic axes. The linear magnetic axis data can be used to calculate the angle using an external CORDIC as well. To calculate the expected error during angular measurement, the contributions from each individual error source must be understood. The relevant error sources include sensitivity error, offset, noise, axis-axis mismatch, nonlinearity, drift across temperature, drift across life time, and so forth. Use the Angle Error Calculation Tool to estimate the total error during angular measurement.

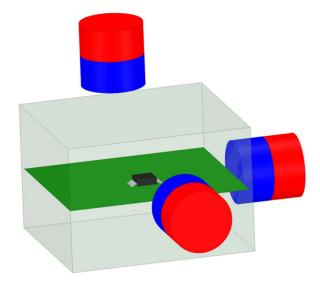
### 7.2 Typical Application

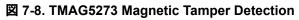
Magnetic 3D sensors are very popular due to contactless and reliable measurements, especially in applications requiring long-term measurements in rugged environments. The TMAG5273 offers design flexibility in wide range of industrial and personal electronics applications. In this section three common application examples are discussed in details.

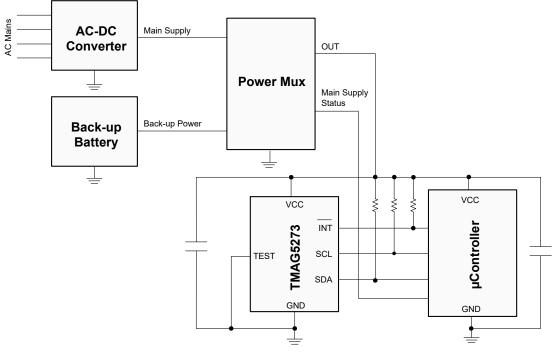
#### 7.2.1 Magnetic Tamper Detection

Given the susceptibility to magnetic tampering, electricity meters often include magnetic sensors designed to detect external magnetic fields and take appropriate actions, such as disconnecting services to the electricity meter or applying a penalty fee for tampering.  $\boxtimes$  7-8 shows that magnetic tampering can result from a permanent magnet in any of the three orientations. Another form of magnetic tampering can be generated through an external coil powered from AC supply mains. The TMAG5273 offers flexible operating modes and configuration of three independent Hall-sensors to detect tampering.











#### 7.2.1.1 Design Requirements

Use the parameters listed in  $\pm$  7-3 for this design example.

| 表 7-1. Design Parameters |                         |                              |  |
|--------------------------|-------------------------|------------------------------|--|
| DESIGN PARAMETERS        | OPERATING ON AC SUPPLY  | OPERATING ON BACK-UP BATTERY |  |
| Device                   | TMAG5273-A2             | TMAG5273-A2                  |  |
| VCC                      | 3.3V                    | 3.6V to 1.7V                 |  |
| Operating Mode           | Continuous measure mode | Wake-up and sleep mode       |  |

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| 表 7-1. Design Parameters (続き)     |  |  |  |
|-----------------------------------|--|--|--|
| DESIGN PARAMETERS                 | OPERATING ON AC SUPPLY   | OPERATING ON BACK-UP BATTERY                             |  |
| Design Objective                  | Read the raw magnetic data and determine<br>the magnitude and type of tampering (AC or<br>DC magnetic field) | Wake up the microcontroller if magnetic tampering occurs |  |
| Timing Budget to Detect Tampering | <100ms   | <5s  |  |
| Desired Battery Life              | N/A  | 5 Year   |  |

#### 7.2.1.2 Detailed Design Procedure

Select a power multiplexer that allows powering the system from AC power line as default option. In case of power outage the power multiplexer automatically switches to back-up battery for powering the system. A status signal from, either the AC-DC regulator or the multiplexer, notifies the microcontroller on power outage events. The microcontroller, upon receiving the status signal, configures the TMAG5273 to operate in wake-up and sleep mode. The TMAG5273 wakes up and measures the magnetic field at a prespecified interval. The device repeats the cycle if no tampering happens. In case of tampering, the device can exit the wake-up and sleep mode and send an interrupt signal to the microcontroller.

Perform the following steps to set the device in continuous measure mode and minimize the number of steps required during battery back-up modes:

- Set the DEVICE\_CONFIG\_1 register to 1h.
- Set the SENSOR CONFIG 1 register to 79h.
- Set the T CONFIG register to 1h.
- Set the INT CONFIG 1 register to A4h.
- Set the DEVICE CONFIG 2 register to 22h.
- Wait for the INT signal assert low to indicate conversion complete. When INT goes low, perform the 16-bit T, X, Y, Z register read with one single read command (see ⊠ 7-10).

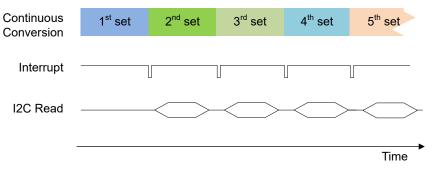


図 7-10. Continuous Conversion With AC Line Power

During power outage event perform only the following steps to set the sensor in the wake-up and sleep mode:

- Set the INT\_CONFIG\_1 register to 64h.
- Set the DEVICE\_CONFIG\_2 register to 23h.
- If a threshold detection even occurs, the INT signal asserts low to wake-up the microcontroller. When INT goes low, perform the 16-bit T, X, Y, Z register read with one single read command (see ⊠ 7-11).



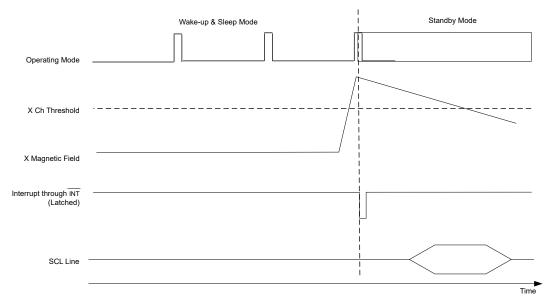
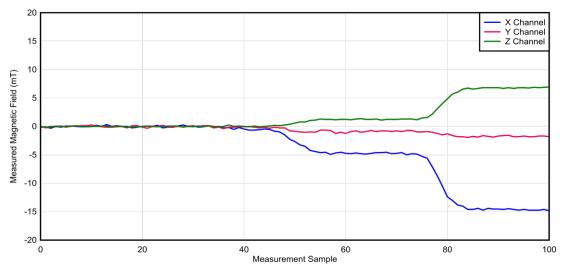


図 7-11. Wake-Up and Sleep Mode Operation With Back-Up Battery



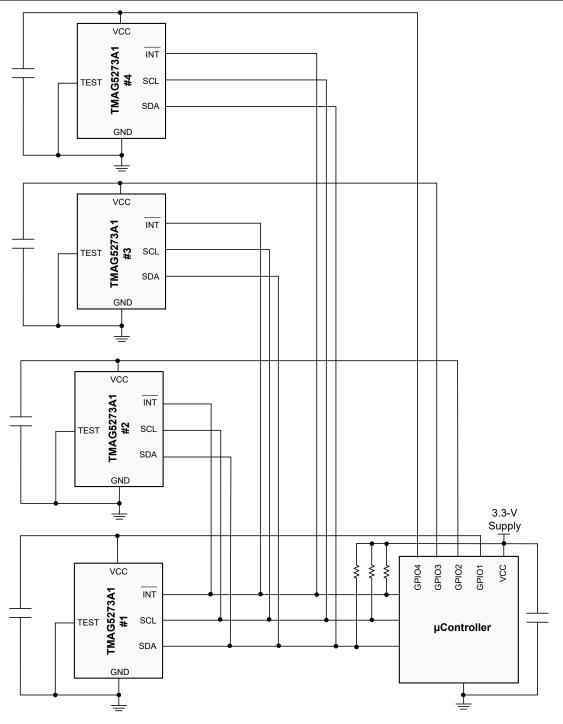




### 7.2.2 I<sup>2</sup>C Address Expansion

The TMAG5273 is offered in four different factory-programmed I<sup>2</sup>C addresses. The device also supports additional I<sup>2</sup>C addresses through the configuration of the I2C\_ADDRESS register. There are 7-bits to select 128 different addresses. Take system limitations like bus loading, maximum clock frequency, available GPIOs from a microcontroller, and so forth, in account before selecting maximum number of sensors in a single I<sup>2</sup>C bus.







## 7.2.2.1 Design Requirements

Use the parameters listed in  $\pm$  7-3 for this design example.

#### 表 7-2. Design Parameters

| PARAMETERS       | DESIGN TARGET |
|------------------|---------------|
| Device orderable | TMAG5273A1    |
| VCC              | 3.3V          |

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### 表 7-2. Design Parameters (続き)

|                           | (   |
|---------------------------|---|
| PARAMETERS                | DESIGN TARGET   |
| # of Devices in same bus  | 4 (same method can be used to expand the number of sensors in the $\rm I^2C$ bus) |
| Design objective          | Optimize the # GPIO and component count   |
| Current supply per sensor | 5mA, supplied by a microcontroller GPIO   |

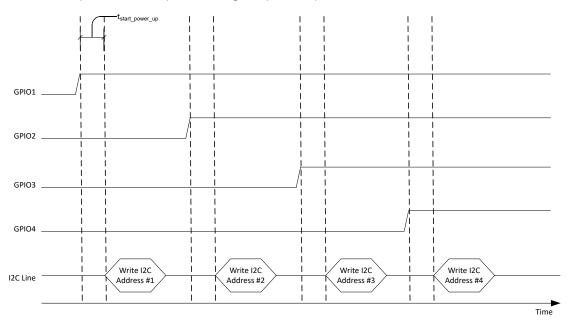
#### 7.2.2.2 Detailed Design Procedure

Select GPIO with current supply capability of 5mA.  $\boxtimes$  7-13 shows that the SCL, SDA lines and  $\overline{INT}$  pin can be shared. However, the function of the  $\overline{INT}$  pin needs to be analyzed when shared by multiple sensors. As an example, if the sensors are configured to generate interrupt through the  $\overline{INT}$  pin, the microcontroller needs to read all the sensors to determine which specific one sending the interrupt. Take the following steps sequentially to assign new I<sup>2</sup>C addresses to the four TMAG5273 shown in  $\boxtimes$  7-14:

• Turn on the GPIO#1 and wait until t<sub>start power up</sub> time is elapsed.

- Address the device#1 with factory programmed address. Write to the I2C\_ADDRESS register to assign a new address.
- Turn on the GPIO#2 and wait until t<sub>start\_power\_up</sub> time is elapsed.
- Address the device#2 with factory programmed address. Write to the I2C\_ADDRESS register to assign a new unique address.
- Turn on the GPIO#3 and wait until t<sub>start power up</sub> time is elapsed.
- Address the device#3 with factory programmed address. Write to the I2C\_ADDRESS register to assign a new unique address.
- Turn on the GPIO#4 and wait until t<sub>start power up</sub> time is elapsed.
- Address the device#4 with factory programmed address. Write to the I2C\_ADDRESS register to assign a new unique address.

Repeat the above steps if there is a power outage or power-up reset condition.





#### 7.2.3 Angle Measurement

Magnetic angle sensors are very popular due to contactless and reliable measurements, especially in applications requiring long-term measurements in rugged environments. The TMAG5273 offers an on-chip angle

calculator providing angular measurement based off any two of the magnetic axes. The two axes of interest can be selected in the ANGLE\_EN register bits. The device offers angle output in complete 360 degree scale. Take several error sources into account for angle calculation, including sensitivity error, offset error, linearity error, noise, mechanical vibration, temperature drift, and so forth.

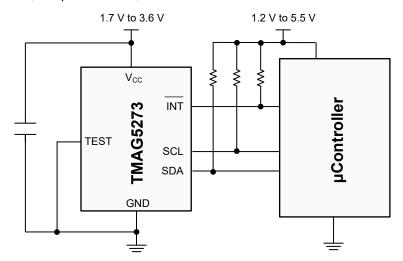


図 7-15. TMAG5273 Application Diagram for Angle Measurement

## 7.2.3.1 Design Requirements

Use the parameters listed in  $\frac{1}{5}$  7-3 for this design example.

| DESIGN PARAMETERS        | ON-AXIS MEASUREMENT  | OFF-AXIS MEASUREMENT   |  |  |  |  |
|--------------------------|--|--|--|--|--|--|
| Device                   | TMAG5273-A1  | TMAG5273-A1  |  |  |  |  |
| VCC                      | 3.3V   | 3.3V   |  |  |  |  |
| Device Position          | Directly under the magnet  | At the adjacent side of the magnet   |  |  |  |  |
| Magnet                   | Cylinder: 4.7625mm diameter, 12.7mm thick,<br>neodymium N52, Br = 1480                                     | Cylinder: 4.7625mm diameter, 12.7mm thick,<br>neodymium N52, Br = 1480                                     |  |  |  |  |
| Magnetic Range Selection | Select the same range for both axes based<br>off the highest possible magnetic field seen<br>by the sensor | Select the same range for both axes based<br>off the highest possible magnetic field seen<br>by the sensor |  |  |  |  |
| RPM                      | <600   | <600   |  |  |  |  |
| Desired Accuracy         | <2° for 360° rotation  | <2° for 360° rotation  |  |  |  |  |
|                          |  |  |  |  |  |  |

## 表 7-3. Design Parameters

## 7.2.3.2 Detailed Design Procedure

For accurate angle measurement, the two axes amplitudes must be normalized by selecting the proper gain adjustment value in the MAG\_GAIN\_CONFIG register. The gain adjustment value is a fractional decimal number between 0 and 1. The following steps must be followed to calculate this fractional value:

- Set the device at 32x average mode and rotate the shaft full 360 degree.
- Record the two axes sensor ADC codes for the full 360 degree rotation.
- A normalized plot for the full 360 degree rotations are represented in 🛛 7-17 or 🖾 7-18.
- Measure the maximum peak-peak ADC code delta for each axis, A<sub>X</sub> and A<sub>Y</sub>.
- If A<sub>X</sub>>A<sub>Y</sub>, set the MAG\_GAIN\_CH register bit to 0b. Calculate the gain adjustment value for X axis:  $G_X = \frac{A_Y}{A_Y}$
- If A<sub>X</sub><A<sub>Y</sub>, set the MAG\_GAIN\_CH register bit to 1b. Calculate the gain adjustment value for Y axis:  $G_Y = \frac{1}{G_Y}$
- The target binary gain setting at the GAIN\_VALUE register bits are calculated from the equation, G<sub>X</sub> or G<sub>Y</sub> = GAIN\_VALUE<sub>decimal</sub>/ 256.



**Example 1:** If  $A_X = A_Y = 60,000$ , the GAIN\_VALUE register bits are set at default 0000 0000b.

**Example 2:** If  $A_X$ = 60,000,  $A_Y$  = 45,000, the  $G_X$  = 45,000/60,000 =0.75. Set MAG\_GAIN\_CH to 0b and GAIN\_VALUE to 1100 0000b.

**Example 3:** If  $A_X$ = 45,000,  $A_Y$  = 60,000, the  $G_X$  = (60,000/45,000) =1.33. Since  $G_X$  >1, the gain adjustment needs to be applied to Y axis with  $G_Y$  =1/ $G_X$ . Set MAG\_GAIN\_CH to 1b and GAIN\_VALUE to 1100 0000b.

#### 7.2.3.2.1 Gain Adjustment for Angle Measurement

Common measurement topology include angular position measurements in on-axis or off-axis angular measurements shown in  $\boxtimes$  7-16. Select the on-axis measurement topology whenever possible as this offers the best optimization of magnetic field and the device measurement ranges. The TMAG5273 offers on-chip gain adjustment option to account for mechanical position misalignments.

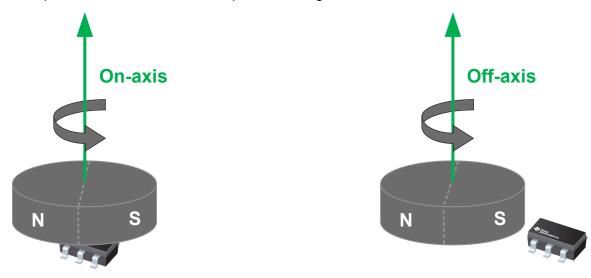
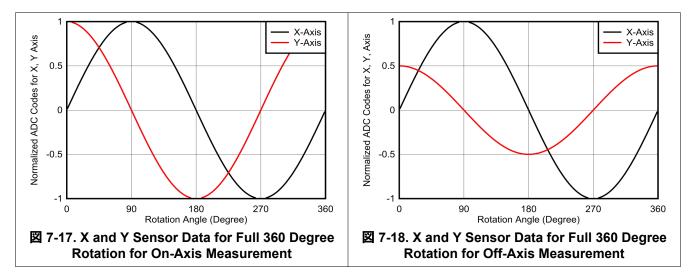


図 7-16. On-Axis vs. Off-Axis Angle Measurements

7.2.3.3 Application Curves



## 7.3 Best Design Practices

The TMAG5273 updates the result registers at the end of a conversion. I<sup>2</sup>C read of the result register needs to be synchronized with the conversion update time to avoid reading a result data while the result register is being



updated. For applications with tight timing budget use the INT signal to notify the primary when a conversion is complete.

## 7.4 Power Supply Recommendations

A decoupling capacitor close to the device must be used to provide local energy with minimal inductance. TI recommends using a ceramic capacitor with a value of at least 0.01µF. Connect the TEST pin to ground.

## 7.5 Layout

#### 7.5.1 Layout Guidelines

Magnetic fields pass through most nonferromagnetic materials with no significant disturbance. Embedding Hall effect sensors within plastic or aluminum enclosures and sensing magnets on the outside is common practice. Magnetic fields also easily pass through most printed-circuit boards (PCBs), which makes placing the magnet on the opposite side of the PCB possible.

## 7.5.2 Layout Example

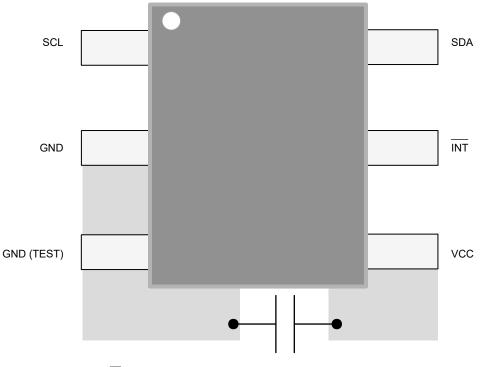


図 7-19. Layout Example With TMAG5273



## 8 Register Maps

## 8.1 TMAG5273 Registers

 $\pm$  8-1 lists the TMAG5273 registers. All register offset addresses not listed in  $\pm$  8-1 should be considered as reserved locations and the register contents should not be modified.

User Configuration Registers

| Offset | Acronym             | Register Name                    | Section |
|--------|---------------------|----------------------------------|---------|
| 0h     | DEVICE_CONFIG_1     | Configure Device Operation Modes | Go      |
| 1h     | DEVICE_CONFIG_2     | Configure Device Operation Modes | Go      |
| 2h     | SENSOR_CONFIG_1     | Sensor Device Operation Modes    | Go      |
| 3h     | SENSOR_CONFIG_2     | Sensor Device Operation Modes    | Go      |
| 4h     | X_THR_CONFIG        | X Threshold Configuration        | Go      |
| 5h     | Y_THR_CONFIG        | Y Threshold Configuration        | Go      |
| 6h     | Z_THR_CONFIG        | Z Threshold Configuration        | Go      |
| 7h     | T_CONFIG            | Temp Sensor Configuration        | Go      |
| 8h     | INT_CONFIG_1        | Configure Device Operation Modes | Go      |
| 9h     | MAG_GAIN_CONFIG     | Configure Device Operation Modes | Go      |
| Ah     | MAG_OFFSET_CONFIG_1 | Configure Device Operation Modes | Go      |
| Bh     | MAG_OFFSET_CONFIG_2 | Configure Device Operation Modes | Go      |
| Ch     | I2C_ADDRESS         | I2C Address Register             | Go      |
| Dh     | DEVICE_ID           | ID for the device die            | Go      |
| Eh     | MANUFACTURER_ID_LSB | Manufacturer ID lower byte       | Go      |
| Fh     | MANUFACTURER_ID_MSB | Manufacturer ID upper byte       | Go      |
| 10h    | T_MSB_RESULT        | Conversion Result Register       | Go      |
| 11h    | T_LSB_RESULT        | Conversion Result Register       | Go      |
| 12h    | X_MSB_RESULT        | Conversion Result Register       | Go      |
| 13h    | X_LSB_RESULT        | Conversion Result Register       | Go      |
| 14h    | Y_MSB_RESULT        | Conversion Result Register       | Go      |
| 15h    | Y_LSB_RESULT        | Conversion Result Register       | Go      |
| 16h    | Z_MSB_RESULT        | Conversion Result Register       | Go      |
| 17h    | Z_LSB_RESULT        | Conversion Result Register       | Go      |
| 18h    | CONV_STATUS         | Conversion Status Register       | Go      |
| 19h    | ANGLE_RESULT_MSB    | Conversion Result Register       | Go      |
| 1Ah    | ANGLE_RESULT_LSB    | Conversion Result Register       | Go      |
| 1Bh    | MAGNITUDE_RESULT    | Conversion Result Register       | Go      |
| 1Ch    | DEVICE_STATUS       | Device_Diag Status Register      | Go      |
|        |                     |                                  |         |

#### 表 8-1. TMAG5273 Registers

Complex bit access types are encoded to fit into small table cells.  $\frac{1}{2}$  8-2 shows the codes that are used for access types in this section.

### 表 8-2. TMAG5273 Access Type Codes

| Access Type | Code | Description |
|-------------|------|-------------|
| Read Type   |      |             |
| R           | R    | Read        |
| Write Type  |      |             |



| 表 8-2. TMAG5273 Access Type Codes (続き) |              |   |  |  |
|--|--------------|---|--|--|
| Access Type                            | Code         | Description                                       |  |  |
| W                                      | W            | Write   |  |  |
| W1CP                                   | W<br>1C<br>P | Write<br>1 to clear<br>Requires privileged access |  |  |
| Reset or Default Value                 |              |   |  |  |
| - n                                    |              | Value after reset or the default value            |  |  |

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## 8.1.1 DEVICE\_CONFIG\_1 Register (Offset = 0h) [Reset = 0h]

DEVICE\_CONFIG\_1 is shown in 表 8-3.

Return to the Summary Table.

#### 表 8-3. DEVICE\_CONFIG\_1 Register Field Descriptions

| Bit | Field      | Туре | Reset | Description   |
|-----|------------|------|-------|---|
| 7   | CRC_EN     | R/W  | Oh    | Enables I2C CRC byte to be sent<br>0h = CRC disabled<br>1h = CRC enabled  |
| 6-5 | MAG_TEMPCO | R/W  | Oh    | Temperature coefficient of the magnet<br>0h = 0% (No temperature compensation)<br>1h = 0.12%/ deg C (NdBFe)<br>2h = Reserved<br>3h = 0.2%/deg C (Ceramic)   |
| 4-2 | CONV_AVG   | R/W  | Oh    | Enables additional sampling of the sensor data to reduce the noise<br>effect (or to increase resolution)<br>0h = 1x average, 10.0-kSPS (3-axes) or 20-kSPS (1 axis)<br>1h = 2x average, 5.7-kSPS (3-axes) or 13.3-kSPS (1 axis)<br>2h = 4x average, 3.1-kSPS (3-axes) or 8.0-kSPS (1 axis)<br>3h = 8x average, 1.6-kSPS (3-axes) or 4.4-kSPS (1 axis)<br>4h = 16x average, 0.8-kSPS (3-axes) or 2.4-kSPS (1 axis)<br>5h = 32x average, 0.4-kSPS (3-axes) or 1.2-kSPS (1 axis) |
| 1-0 | I2C_RD     | R/W  | Oh    | Defines the I2C read mode<br>Oh = Standard I2C 3-byte read command<br>1h = 1-byte I2C read command for 16bit sensor data and conversion<br>status<br>2h = 1-byte I2C read command for 8 bit sensor MSB data and<br>conversion status<br>3h = Reserved   |

## 8.1.2 DEVICE\_CONFIG\_2 Register (Offset = 1h) [Reset = 0h]

DEVICE\_CONFIG\_2 is shown in 表 8-4.

Return to the Summary Table.



| 表 8-4. DEVICE_CONFIG_2 Register Field Descriptions |                   |      |       |   |  |
|--|-------------------|------|-------|---|--|
| Bit  | Field             | Туре | Reset | Description   |  |
| 7-5  | THR_HYST          | R/W  | 0h    | Select thresholds for the interrupt function<br>Oh = Takes the 2's complement value of each x_THR_CONFIG<br>register to create a magnetic threshold of the corresponding axis<br>1h = Takes the 7 LSB bits of the x_THR_CONFIG register to create<br>two opposite magnetic thresholds (one north, and another south) of<br>equal magnitude.<br>2h = Reserved<br>3h = Reserved<br>4h = Reserved<br>5h = Reserved<br>6h = Reserved<br>7h = Reserved |  |
| 4  | LP_LN             | R/W  | 0h    | Selects the modes between low active current or low-noise modes<br>0h = Low active current mode<br>1h = Low noise mode  |  |
| 3  | I2C_GLITCH_FILTER | R/W  | 0h    | I2C glitch filter<br>0h = Glitch filter on<br>1h = Glitch filter off  |  |
| 2  | TRIGGER_MODE      | R/W  | Oh    | Selects a condition which initiates a single conversion based off<br>already configured registers. A running conversion completes before<br>executing a trigger. Redundant triggers are ignored.<br>TRIGGER_MODE is available only during the mode explicitly<br>mentioned in OPERATING_MODE.<br>0h = Conversion Start at I2C Command Bits, DEFAULT<br>1h = Conversion starts through trigger signal at INT pin                                   |  |
| 1-0  | OPERATING_MODE    | R/W  | Oh    | Selects Operating Mode and updates value based on operating<br>mode if device transitions from Wake-up and sleep mode to Standby<br>mode.<br>Oh = Standby mode (starts new conversion at trigger event)<br>1h = Sleep mode<br>2h = Continuous measure mode<br>3h = Wake-up and sleep mode (W&S mode)  |  |

#### DEVICE CONFIG OD ale to a Field December the sec + ~ 4

## 8.1.3 SENSOR\_CONFIG\_1 Register (Offset = 2h) [Reset = 0h]

SENSOR\_CONFIG\_1 is shown in 表 8-5.

Return to the Summary Table.

| 表 8-5. SENSOR | CONFIG <sup>4</sup> | l Register Field | Descriptions |
|---------------|---------------------|------------------|--------------|
|               |                     |                  |              |

| Bit | Field     | Туре | Reset | Description  |
|-----|-----------|------|-------|--|
| 7-4 | MAG_CH_EN | R/W  | Oh    | Enables data acquisition of the magnetic axis channel(s)<br>0h = All magnetic channels of off, DEFAULT<br>1h = X channel enabled<br>2h = Y channel enabled<br>3h = X, Y channel enabled<br>4h = Z channel enabled<br>5h = Z, X channel enabled<br>6h = Y, Z channel enabled<br>7h = X, Y, Z channel enabled<br>8h = XYX channel enabled<br>9h = YXY channel enabled<br>Ah = YZY channel enabled<br>Bh = XZX channel enabled<br>Ch = Reserved<br>Dh = Reserved<br>Fh = Reserved |



### 表 8-5. SENSOR\_CONFIG\_1 Register Field Descriptions (続き)

| Bit | Field     | Туре | Reset | Description  |
|-----|-----------|------|-------|--|
| 3-0 | SLEEPTIME | R/W  | Oh    | Selects the time spent in low power mode between conversions<br>when OPERATING_MODE =11b<br>0h = 1ms<br>1h = 5ms<br>2h = 10ms<br>3h = 15ms<br>4h = 20ms<br>5h = 30ms<br>6h = 50ms<br>7h = 100ms<br>8h = 500ms<br>9h = 1000ms<br>Ah = 2000ms<br>Bh = 5000ms<br>Ch = 20000ms |

## 8.1.4 SENSOR\_CONFIG\_2 Register (Offset = 3h) [Reset = 0h]

SENSOR\_CONFIG\_2 is shown in 表 8-6.

Return to the Summary Table.

#### 表 8-6. SENSOR\_CONFIG\_2 Register Field Descriptions

| Bit | Field       | Туре | Reset | Description  |
|-----|-------------|------|-------|--|
| 7   | RESERVED    | R    | 0h    | Reserved   |
| 6   | THRX_COUNT  | R/W  | Oh    | Number of threshold crossings before the interrupt is asserted<br>0h = 1 threshold crossing<br>1h = 4 threshold crossing   |
| 5   | MAG_THR_DIR | R/W  | Oh    | Selects the direction of threshold check. This bit is ignored when<br>THR_HYST > 001b<br>Oh = sets interrupt for field above the threshold<br>1h = sets interrupt for field below the threshold  |
| 4   | MAG_GAIN_CH | R/W  | Oh    | Selects the axis for magnitude gain correction value entered in<br>MAG_GAIN_CONFIG register<br>0h = 1st channel is selected for gain adjustment<br>1h = 2nd channel is selected for gain adjustment  |
| 3-2 | ANGLE_EN    | R/W  | Oh    | Enables angle calculation, magnetic gain, and offset corrections<br>between two selected magnetic channels<br>0h = No angle calculation, magnitude gain, and offset correction<br>enabled<br>1h = X 1st, Y 2nd<br>2h = Y 1st, Z 2nd<br>3h = X 1st, Z 2nd |
| 1   | X_Y_RANGE   | R/W  | Oh    | Select the X and Y axes magnetic range from 2 different options.<br>0h = ±40mT (TMAG5273A1) or ±133mT (TMAG5273A2), DEFAULT<br>1h = ±80mT (TMAG5273A1) or ±266mT (TMAG5273A2)  |
| 0   | Z_RANGE     | R/W  | Oh    | Select the Z axis magnetic range from 2 different options.<br>Oh = ±40mT (TMAG5273A1) or ±133mT (TMAG5273A2), DEFAULT<br>1h = ±80mT (TMAG5273A1) or ±266mT (TMAG5273A2)  |

## 8.1.5 X\_THR\_CONFIG Register (Offset = 4h) [Reset = 0h]

X\_THR\_CONFIG is shown in 表 8-7.

Return to the Summary Table.



|     | A 0-7. A_THK_CONFIG Register Field Descriptions |      |       |  |  |  |
|-----|---|------|-------|--|--|--|
| Bit | Field   | Туре | Reset | Description  |  |  |
| 7-0 | X_THR_CONFIG                                    | R/W  | 0h    | 8-bit, 2's complement X axis threshold code for limit check. The range of possible threshold entrees can be +/-128. The threshold value in mT is calculated for A1 as (40(1+X_Y_RANGE)/ 128)*X_THR_CONFIG, for A2 as (133(1+X_Y_RANGE)/ 128)*X_THR_CONFIG. Default 0h means no threshold comparison. |  |  |

## 表 8-7. X\_THR\_CONFIG Register Field Descriptions

## 8.1.6 Y\_THR\_CONFIG Register (Offset = 5h) [Reset = 0h]

Y\_THR\_CONFIG is shown in 表 8-8.

Return to the Summary Table.

#### 表 8-8. Y\_THR\_CONFIG Register Field Descriptions

| Bit | Field        | Туре | Reset | Description  |
|-----|--------------|------|-------|--|
| 7-0 | Y_THR_CONFIG | R/W  |       | 8-bit, 2's complement Y axis threshold code for limit check. The range of possible threshold entrees can be +/-128. The threshold value in mT is calculated for A1 as (40(1+X_Y_RANGE)/ 128)*X_THR_CONFIG, for A2 as (133(1+X_Y_RANGE)/ 128)*X_THR_CONFIG. Default 0h means no threshold comparison. |

## 8.1.7 Z\_THR\_CONFIG Register (Offset = 6h) [Reset = 0h]

Z\_THR\_CONFIG is shown in  $\frac{1}{8}$  8-9.

Return to the Summary Table.

#### 表 8-9. Z\_THR\_CONFIG Register Field Descriptions

| Bit | Field        | Туре | Reset | Description  |
|-----|--------------|------|-------|--|
| 7-0 | Z_THR_CONFIG | R/W  |       | 8-bit, 2's complement Z axis threshold code for limit check. The range of possible threshold entrees can be +/-128. The threshold value in mT is calculated for A1 as (40(1+Z_RANGE)/<br>128)*Z_THR_CONFIG, for A2 as (133(1+Z_RANGE)/<br>128)*Z_THR_CONFIG. Default 0h means no threshold comparison. |

## 8.1.8 T\_CONFIG Register (Offset = 7h) [Reset = 0h]

T\_CONFIG is shown in 表 8-10.

Return to the Summary Table.

#### 表 8-10. T\_CONFIG Register Field Descriptions

| Bit | Field        | Туре | Reset | Description   |  |  |
|-----|--------------|------|-------|---|--|--|
| 7-1 | T_THR_CONFIG | R/W  | 0h    | Temperature threshold code entered by user. The valid temperature threshold ranges are -41C to 170C with the threshold codes for -41C = 1Ah, and 170C = 34h. Resolution is 8 degree C/ LSB. Default 0h means no threshold comparison. |  |  |
| 0   | T_CH_EN      | R/W  | 0h    | Enables data acquisition of the temperature channel<br>0h = Temp channel disabled<br>1h = Temp channel enabled  |  |  |

## 8.1.9 INT\_CONFIG\_1 Register (Offset = 8h) [Reset = 0h]

INT\_CONFIG\_1 is shown in 表 8-11.



#### Return to the Summary Table.

| Bit | Field      | Туре | Reset | Description  |
|-----|------------|------|-------|--|
| 7   | RSLT_INT   | R/W  | 0h    | Enable interrupt response on conversion complete.<br>0h = Interrupt is not asserted when the configured set of conversions<br>are complete<br>1h = Interrupt is asserted when the configured set of conversions are<br>complete  |
| 6   | THRSLD_INT | R/W  | 0h    | Enable interrupt response on a predefined threshold cross.<br>Oh = Interrupt is not asserted when a threshold is crossed<br>1h = Interrupt is asserted when a threshold is crossed   |
| 5   | INT_STATE  | R/W  | Oh    | $\overline{INT}$ interrupt latched or pulsed.<br>Oh = $\overline{INT}$ interrupt latched until clear by a primary addressing the device<br>1h = $\overline{INT}$ interrupt pulse for 10us  |
| 4-2 | INT_MODE   | R/W  | Oh    | Interrupt mode select.<br>Oh = No interrupt<br>1h = Interrupt through INT<br>2h = Interrupt through INT except when I2C bus is busy.<br>3h = Interrupt through SCL<br>4h = Interrupt through SCL except when I2C bus is busy.<br>5h = Reserved<br>6h = Reserved<br>7h = Reserved |
| 1   | RESERVED   | R    | 0h    | Reserved   |
| 0   | MASK_INTB  | R/W  | Oh    | Mask INT pin when INT connected to GND<br>0h = INT pin is enabled<br>1h = INT pin is disabled (for wake-up and trigger functions)  |

#### 表 8-11. INT\_CONFIG\_1 Register Field Descriptions

## 8.1.10 MAG\_GAIN\_CONFIG Register (Offset = 9h) [Reset = 0h]

MAG\_GAIN\_CONFIG is shown in 表 8-12.

Return to the Summary Table.

## 表 8-12. MAG\_GAIN\_CONFIG Register Field Descriptions

| Bit | Field      | Туре | Reset | Description   |
|-----|------------|------|-------|---|
| 7-0 | GAIN_VALUE | R/W  |       | 8-bit gain value determined by a primary to adjust a Hall axis gain.<br>The particular axis is selected based off the settings of<br>MAG_GAIN_CH and ANGLE_EN register bits. The binary 8-bit input<br>is interpreted as a fractional value in between 0 and 1 based off the<br>formula, 'user entered value in decimal/256'. Gain value of 0 is<br>interpreted by the device as 1. |

## 8.1.11 MAG\_OFFSET\_CONFIG\_1 Register (Offset = Ah) [Reset = 0h]

MAG\_OFFSET\_CONFIG\_1 is shown in 表 8-13.

Return to the Summary Table.

## 表 8-13. MAG\_OFFSET\_CONFIG\_1 Register Field Descriptions

| Bit | Field            | Туре | Reset | Description  |
|-----|------------------|------|-------|--|
| -   | OFFSET_VALUE_1ST | R/W  | Oh    | 8-bit, 2's complement offset value determined by a primary to adjust first axis offset value. The range of possible offset valid entrees can be +/-128. The offset value is calculated by multiplying bit resolution with the entered value. |

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## 8.1.12 MAG\_OFFSET\_CONFIG\_2 Register (Offset = Bh) [Reset = 0h]

MAG\_OFFSET\_CONFIG\_2 is shown in 表 8-14.

Return to the Summary Table.

#### 表 8-14. MAG\_OFFSET\_CONFIG\_2 Register Field Descriptions

| Bit | Field            | Туре | Reset | Description   |
|-----|------------------|------|-------|---|
| 7-0 | OFFSET_VALUE_2ND | R/W  |       | 8-bit, 2's complement offset value determined by a primary to adjust second axis offset value. The range of possible offset valid entrees can be +/-128. The offset value is calculated by multiplying bit resolution with the entered value. |

## 8.1.13 I2C\_ADDRESS Register (Offset = Ch) [Reset = 6Ah]

I2C\_ADDRESS is shown in 表 8-15.

Return to the Summary Table.

#### 表 8-15. I2C\_ADDRESS Register Field Descriptions

| Bit | Field                     | Туре | Reset | Description   |
|-----|---------------------------|------|-------|---|
| 7-1 | I2C_ADDRESS               | R/W  | 35h   | 7-bit default factory I2C address is loaded from OTP during first<br>power up. Change these bits to a new setting if a new I2C address is<br>required (at each power cycle these bits must be written again to<br>avoid going back to default factory address). |
| 0   | I2C_ADDRESS_UPDATE<br>_EN | R/W  | 0h    | Enable a new user defined I2C address.<br>0h = Disable update of I2C address<br>1h = Enable update of I2C address with bits (7:1)   |

## 8.1.14 DEVICE\_ID Register (Offset = Dh) [Reset = xh]

DEVICE ID is shown in 表 8-16.

Return to the Summary Table.

#### 表 8-16. DEVICE\_ID Register Field Descriptions

| Bit | Field    | Туре | Reset | Description   |
|-----|----------|------|-------|---|
| 7-2 | RESERVED | R    | xh    | Reserved  |
| 1-0 | VER      | R    | xh    | Device version indicator. Reset value of DEVICE_ID depends on the<br>orderable part number.<br>0h = Reserved<br>1h = ±40-mT and ±80-mT range<br>2h = ±133-mT and ±266-mT range<br>3h = Reserved |

## 8.1.15 MANUFACTURER\_ID\_LSB Register (Offset = Eh) [Reset = 49h]

MANUFACTURER\_ID\_LSB is shown in 表 8-17.

Return to the Summary Table.

#### 表 8-17. MANUFACTURER\_ID\_LSB Register Field Descriptions

| Bit | Field                     | Туре | Reset | Description                  |
|-----|---------------------------|------|-------|------------------------------|
| 7-0 | MANUFACTURER_ID_[7:<br>0] | R    | 49h   | 8-bit unique manufacturer ID |



## 8.1.16 MANUFACTURER\_ID\_MSB Register (Offset = Fh) [Reset = 54h]

MANUFACTURER\_ID\_MSB is shown in 表 8-18.

Return to the Summary Table.

#### 表 8-18. MANUFACTURER\_ID\_MSB Register Field Descriptions

| Bit | Field               | Туре | Reset | Description                  |
|-----|---------------------|------|-------|------------------------------|
| 7-0 | MANUFACTURER_ID_[15 | R    | 54h   | 8-bit unique manufacturer ID |
|     | :8]                 |      |       |                              |

## 8.1.17 T\_MSB\_RESULT Register (Offset = 10h) [Reset = 0h]

T\_MSB\_RESULT is shown in 表 8-19.

Return to the Summary Table.

#### 表 8-19. T\_MSB\_RESULT Register Field Descriptions

| Bit | Field              | Туре | Reset | Description                                    |
|-----|--------------------|------|-------|--|
| 7-0 | T_CH_RESULT [15:8] | R    | 0h    | T-channel data conversion results, MSB 8 bits. |

## 8.1.18 T\_LSB\_RESULT Register (Offset = 11h) [Reset = 0h]

T\_LSB\_RESULT is shown in 表 8-20.

Return to the Summary Table.

#### 表 8-20. T LSB RESULT Register Field Descriptions

| Bit | Field             | Туре | Reset | Description                                    |
|-----|-------------------|------|-------|--|
| 7-0 | T_CH_RESULT [7:0] | R    | 0h    | T-channel data conversion results, LSB 8 bits. |

#### 8.1.19 X\_MSB\_RESULT Register (Offset = 12h) [Reset = 0h]

X\_MSB\_RESULT is shown in 表 8-21.

Return to the Summary Table.

#### 表 8-21. X\_MSB\_RESULT Register Field Descriptions

| Bit | Field              | Туре | Reset | Description                                    |
|-----|--------------------|------|-------|--|
| 7-0 | X_CH_RESULT [15:8] | R    | 0h    | X-channel data conversion results, MSB 8 bits. |

#### 8.1.20 X\_LSB\_RESULT Register (Offset = 13h) [Reset = 0h]

X\_LSB\_RESULT is shown in 表 8-22.

Return to the Summary Table.

#### 表 8-22. X\_LSB\_RESULT Register Field Descriptions

| Bit | Field             | Туре | Reset | Description                                    |
|-----|-------------------|------|-------|--|
| 7-0 | X_CH_RESULT [7:0] | R    | 0h    | X-channel data conversion results, LSB 8 bits. |

## 8.1.21 Y\_MSB\_RESULT Register (Offset = 14h) [Reset = 0h]

Y\_MSB\_RESULT is shown in 表 8-23.



Return to the Summary Table.

#### 表 8-23. Y\_MSB\_RESULT Register Field Descriptions

| Bit | Field              | Туре | Reset | Description                                    |
|-----|--------------------|------|-------|--|
| 7-0 | Y_CH_RESULT [15:8] | R    | 0h    | Y-channel data conversion results, MSB 8 bits. |

#### 8.1.22 Y\_LSB\_RESULT Register (Offset = 15h) [Reset = 0h]

Y\_LSB\_RESULT is shown in 表 8-24.

Return to the Summary Table.

#### 表 8-24. Y\_LSB\_RESULT Register Field Descriptions

| Bit | Field             | Туре | Reset | Description                                    |
|-----|-------------------|------|-------|--|
| 7-0 | Y_CH_RESULT [7:0] | R    | 0h    | Y-channel data conversion results, LSB 8 bits. |

#### 8.1.23 Z\_MSB\_RESULT Register (Offset = 16h) [Reset = 0h]

Z\_MSB\_RESULT is shown in 表 8-25.

Return to the Summary Table.

#### 表 8-25. Z\_MSB\_RESULT Register Field Descriptions

| _ |     |                    |      |       |  |  |  |
|---|-----|--------------------|------|-------|--|--|--|
|   | Bit | Field              | Туре | Reset | Description                                    |  |  |
|   | 7-0 | Z_CH_RESULT [15:8] | R    | 0h    | Z-channel data conversion results, MSB 8 bits. |  |  |

#### 8.1.24 Z\_LSB\_RESULT Register (Offset = 17h) [Reset = 0h]

Z LSB RESULT is shown in 表 8-26.

Return to the Summary Table.

#### 表 8-26. Z\_LSB\_RESULT Register Field Descriptions

| Bit | Field             | Туре | Reset | Description                                    |
|-----|-------------------|------|-------|--|
| 7-0 | Z_CH_RESULT [7:0] | R    | 0h    | Z-channel data conversion results, LSB 8 bits. |

#### 8.1.25 CONV\_STATUS Register (Offset = 18h) [Reset = 10h]

CONV\_STATUS is shown in 表 8-27.

Return to the Summary Table.

#### 表 8-27. CONV\_STATUS Register Field Descriptions

| Bit | Field       | Туре   | Reset | Description   |
|-----|-------------|--------|-------|---|
| 7-5 | SET_COUNT   | R      | 0h    | Rolling Count of Conversion Data Sets   |
| 4   | POR         | R/W1CP | 1h    | Device powered up, or experienced power-on-reset. Bit is clear when<br>host writes back 1.<br>0h = No POR<br>1h = POR occurred  |
| 3-2 | RESERVED    | R      | 0h    | Reserved  |
| 1   | DIAG_STATUS | R      | 0h    | Detect any internal diagnostics fail which include VCC UV, internal<br>memory CRC error, INT pin error and internal clock error. Ignore this<br>bit status if VCC < 2.3V.<br>0h = No diag fail<br>1h = Diag fail detected |

#### 表 8-27. CONV\_STATUS Register Field Descriptions (続き)

| Bit | Field         | Туре | Reset | Description   |
|-----|---------------|------|-------|---|
| 0   | RESULT_STATUS | R    |       | Conversion data buffer is ready to be read.<br>0h = Conversion data not complete<br>1h = Conversion data complete |

## 8.1.26 ANGLE\_RESULT\_MSB Register (Offset = 19h) [Reset = 0h]

ANGLE\_RESULT\_MSB is shown in 表 8-28.

Return to the Summary Table.

#### 表 8-28. ANGLE\_RESULT\_MSB Register Field Descriptions

| Bit | Field            | Туре | Reset | Description  |
|-----|------------------|------|-------|--|
| 7-0 | ANGLE_RESULT_MSB | R    | Oh    | Angle measurement result in degree. The data is displayed from 0 to 360 degree in 13 LSB bits after combining the ANGLE_RESULT_MSB and _LSB bits. The 4 LSB bits allocated for fraction of an angle in the format (xxxx/16). |

#### 8.1.27 ANGLE\_RESULT\_LSB Register (Offset = 1Ah) [Reset = 0h]

ANGLE\_RESULT\_LSB is shown in 表 8-29.

Return to the Summary Table.

#### 表 8-29. ANGLE\_RESULT\_LSB Register Field Descriptions

| Bit | Field            | Туре | Reset | Description  |
|-----|------------------|------|-------|--|
| 7-0 | ANGLE_RESULT_LSB | R    | 0h    | Angle measurement result in degree. The data is displayed from 0 to 360 degree in 13 LSB bits after combining the ANGLE_RESULT_MSB and _LSB bits. The 4 LSB bits allocated for fraction of an angle in the format (xxxx/16). |

#### 8.1.28 MAGNITUDE\_RESULT Register (Offset = 1Bh) [Reset = 0h]

MAGNITUDE\_RESULT is shown in 表 8-30.

Return to the Summary Table.

#### 表 8-30. MAGNITUDE\_RESULT Register Field Descriptions

|     |                  |      | _ | <u> </u>   |
|-----|------------------|------|---|--|
| Bit | Field            | Туре |   |  |
| 7-0 | MAGNITUDE_RESULT | R    |   | Resultant vector magnitude (during angle measurement) result. This value should be constant during 360 degree measurements |

## 8.1.29 DEVICE\_STATUS Register (Offset = 1Ch) [Reset = 10h]

DEVICE\_STATUS is shown in 表 8-31.

Return to the Summary Table.

#### 表 8-31. DEVICE\_STATUS Register Field Descriptions

| Bit | Field    | Туре | Reset | Description |
|-----|----------|------|-------|-------------|
| 7-5 | RESERVED | R    | 0h    | Reserved    |

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## 表 8-31. DEVICE\_STATUS Register Field Descriptions (続き)

| Bit | Field      | Туре   | Reset | Description   |  |  |  |  |
|-----|------------|--------|-------|---|--|--|--|--|
| 4   | INTB_RB    | R      | 1h    | Indicates the level that the device is reading back from $\overline{INT}$ pin. The reset value of DEVICE_STATUS depends on the status of the $\overline{INT}$ pin at power-up.<br>Oh = $\overline{INT}$ pin driven low<br>1h = $\overline{INT}$ pin status high |  |  |  |  |
| 3   | OSC_ER     | R/W1CP | 0h    | Indicates if Oscillator error is detected. Bit is clear when host writes<br>back 1.<br>0h = No Oscillator error detected<br>1h = Oscillator error detected  |  |  |  |  |
| 2   | INT_ER     | R/W1CP | 0h    | Indicates if $\overline{INT}$ pin error is detected. Bit is clear when host writes<br>back 1.<br>0h = No $\overline{INT}$ error detected<br>1h = $\overline{INT}$ error detected  |  |  |  |  |
| 1   | OTP_CRC_ER | R/W1CP | 0h    | Indicates if OTP CRC error is detected. Bit is clear when host writes<br>back 1.<br>0h = No OTP CRC error detected<br>1h = OTP CRC error detected   |  |  |  |  |
| 0   | VCC_UV_ER  | R/W1CP | 0h    | Indicates if VCC undervoltage was detected. Bit is clear when host<br>writes back 1. Ignore this bit status if VCC < 2.3V.<br>0h = No VCC UV detected<br>1h = VCC UV detected   |  |  |  |  |



## 9 Device and Documentation Support

## 9.1 Documentation Support

### 9.1.1 Related Documentation

For related documentation see the following:

- Texas Instruments, HALL-ADAPTER-EVM User's Guide
- Texas Instruments, TMAG5173 Evaluation Manual user's guide
- Texas Instruments, Angle Measurement With Multi-Axis Linear Hall-Effect Sensors application note
- Texas Instruments, Absolute Angle Measurements for Rotational Motion Using Hall-Effect Sensors application brief
- Texas Instruments, *Limit Detection for Tamper and End-of-Travel Detection Using Hall-Effect Sensors* application brief

## 9.2 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、www.tij.co.jpのデバイス製品フォルダを開いてください。[通知]をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取ることができます。変更の詳細については、改訂されたドキュメントに含まれている改訂履歴をご覧ください。

## 9.3 サポート・リソース

テキサス・インスツルメンツ E2E<sup>™</sup> サポート・フォーラムは、エンジニアが検証済みの回答と設計に関するヒントをエキスパートから迅速かつ直接得ることができる場所です。既存の回答を検索したり、独自の質問をしたりすることで、設計で必要な支援を迅速に得ることができます。

リンクされているコンテンツは、各寄稿者により「現状のまま」提供されるものです。これらはテキサス・インスツルメンツの仕様を構成するものではなく、必ずしもテキサス・インスツルメンツの見解を反映したものではありません。テキサス・インスツ ルメンツの使用条件を参照してください。

## 9.4 Trademarks

テキサス・インスツルメンツ E2E<sup>™</sup> is a trademark of Texas Instruments. すべての商標は、それぞれの所有者に帰属します。

## 9.5 静電気放電に関する注意事項



この IC は、ESD によって破損する可能性があります。テキサス・インスツルメンツは、IC を取り扱う際には常に適切な注意を払うことを推奨します。正しい取り扱いおよび設置手順に従わない場合、デバイスを破損するおそれがあります。

ESD による破損は、わずかな性能低下からデバイスの完全な故障まで多岐にわたります。精密な IC の場合、パラメータがわずか に変化するだけで公表されている仕様から外れる可能性があるため、破損が発生しやすくなっています。

## 9.6 用語集

テキサス・インスツルメンツ用語集 この用語集には、用語や略語の一覧および定義が記載されています。

## 10 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

| C | hanges from Revision A (September 2021) to Revision B (July 2024)                              | Page           |
|---|--|----------------|
| • | Updated formatting of ICC DCM parameter in the <i>Electrical Characteristics</i> section       | 6              |
| • | Updated the formatting of the Magnetic Characteristics for A1 test conditions                  | <mark>8</mark> |
| • | Updated the formatting of the Magnetic Characteristics for A2 test conditions                  | 9              |
| • | Updated the formatting of the Power up & Conversion Time test conditions                       |                |
| • | Added information about the INT function during the transition from sleep mode to standby mode |                |
| • | Added sentence: The result interrupt function is not available during the W&S mode             |                |
| • | Removed the exception note with CRC support for long data stream                               |                |

| TMAG5273<br>JAJSJS6B – JUNE 2021 – REVISED JULY 2024  | TEXAS<br>INSTRUMENTS<br>www.ti.com/ja-jp |
|---|--|
| <ul> <li>Removed the exception note with CRC enabled</li> <li>Changed DEVICE_ID register reset from 1h to xh</li> </ul> |  |

| С | hanges from Revision * (June 2021) to Revision A (September 2021) | Page |
|---|---|------|
| • | データシート ステータスを「事前情報」から「量産データ」に変更                                   | 1    |

## 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



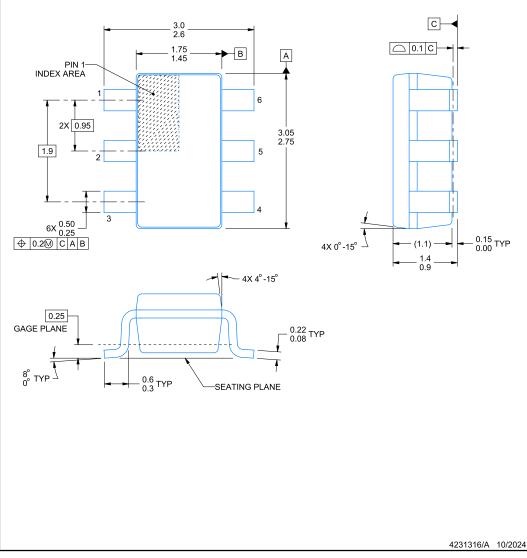
## TMAG5173xxx/TMAG5273xxx DBV0006A-C02



## **PACKAGE OUTLINE**

#### SOT-23 - 1.4 mm max height

SMALL OUTLINE TRANSISTOR



NOTES:

All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 This drawing is subject to change without notice.
 Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.25 per side.
 Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
 Refernce JEDEC MO-178.



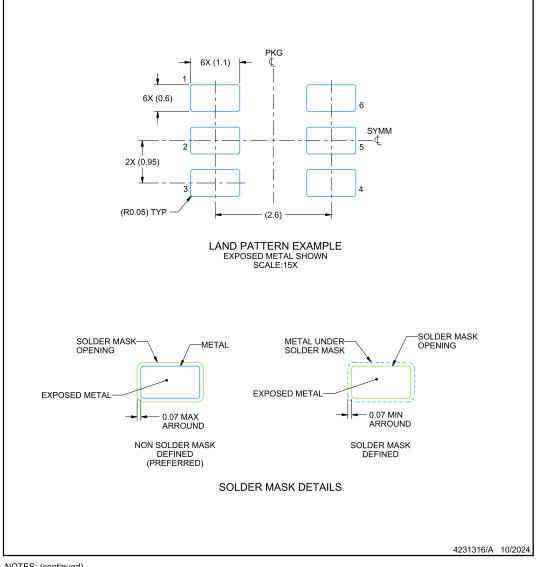


## **EXAMPLE BOARD LAYOUT**

## TMAG5173xxx/TMAG5273xxx DBV0006A-C02

#### SOT-23 - 1.4 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

Publication IPC-7351 may have alternate designs.
 Solder mask tolerances between and around signal pads can vary based on board fabrication site.



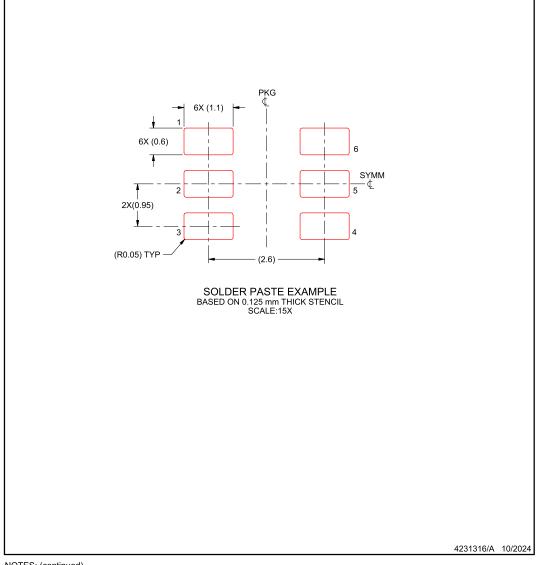


## **EXAMPLE STENCIL DESIGN**

## TMAG5173xxx/TMAG5273xxx DBV0006A-C02

## SOT-23 - 1.4 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate

design recommendations. 9. Board assembly site may have different recommendations for stencil design.





## PACKAGING INFORMATION

| Orderable part number | Status<br>(1) | Material type (2) | Package   Pins   | Package qty   Carrier | <b>RoHS</b><br>(3) | Lead finish/<br>Ball material | MSL rating/<br>Peak reflow | Op temp (°C) | Part marking<br>(6) |
|-----------------------|---------------|-------------------|------------------|-----------------------|--------------------|-------------------------------|----------------------------|--------------|---------------------|
|                       |               |                   |                  |                       |                    | (4)                           | (5)                        |              |                     |
| TMAG5273A1QDBVR       | Active        | Production        | SOT-23 (DBV)   6 | 3000   LARGE T&R      | Yes                | SN                            | Level-3-260C-168 HR        | -40 to 125   | 52A1                |
| TMAG5273A1QDBVR.A     | Active        | Production        | SOT-23 (DBV)   6 | 3000   LARGE T&R      | Yes                | SN                            | Level-3-260C-168 HR        | -40 to 125   | 52A1                |
| TMAG5273A1QDBVT       | Obsolete      | Production        | SOT-23 (DBV)   6 | -                     | -                  | Call TI                       | Call TI                    | -40 to 125   | 52A1                |
| TMAG5273A2QDBVR       | Active        | Production        | SOT-23 (DBV)   6 | 3000   LARGE T&R      | Yes                | SN                            | Level-3-260C-168 HR        | -40 to 125   | 52A2                |
| TMAG5273A2QDBVR.A     | Active        | Production        | SOT-23 (DBV)   6 | 3000   LARGE T&R      | Yes                | SN                            | Level-3-260C-168 HR        | -40 to 125   | 52A2                |
| TMAG5273B1QDBVR       | Active        | Production        | SOT-23 (DBV)   6 | 3000   LARGE T&R      | Yes                | SN                            | Level-3-260C-168 HR        | -40 to 125   | 52B1                |
| TMAG5273B1QDBVR.A     | Active        | Production        | SOT-23 (DBV)   6 | 3000   LARGE T&R      | Yes                | SN                            | Level-3-260C-168 HR        | -40 to 125   | 52B1                |
| TMAG5273B2QDBVR       | Active        | Production        | SOT-23 (DBV)   6 | 3000   LARGE T&R      | Yes                | SN                            | Level-3-260C-168 HR        | -40 to 125   | 52B2                |
| TMAG5273B2QDBVR.A     | Active        | Production        | SOT-23 (DBV)   6 | 3000   LARGE T&R      | Yes                | SN                            | Level-3-260C-168 HR        | -40 to 125   | 52B2                |
| TMAG5273C1QDBVR       | Active        | Production        | SOT-23 (DBV)   6 | 3000   LARGE T&R      | Yes                | SN                            | Level-3-260C-168 HR        | -40 to 125   | 52C1                |
| TMAG5273C1QDBVR.A     | Active        | Production        | SOT-23 (DBV)   6 | 3000   LARGE T&R      | Yes                | SN                            | Level-3-260C-168 HR        | -40 to 125   | 52C1                |
| TMAG5273C2QDBVR       | Active        | Production        | SOT-23 (DBV)   6 | 3000   LARGE T&R      | Yes                | SN                            | Level-3-260C-168 HR        | -40 to 125   | 52C2                |
| TMAG5273C2QDBVR.A     | Active        | Production        | SOT-23 (DBV)   6 | 3000   LARGE T&R      | Yes                | SN                            | Level-3-260C-168 HR        | -40 to 125   | 52C2                |
| TMAG5273D1QDBVR       | Active        | Production        | SOT-23 (DBV)   6 | 3000   LARGE T&R      | Yes                | SN                            | Level-3-260C-168 HR        | -40 to 125   | 52D1                |
| TMAG5273D1QDBVR.A     | Active        | Production        | SOT-23 (DBV)   6 | 3000   LARGE T&R      | Yes                | SN                            | Level-3-260C-168 HR        | -40 to 125   | 52D1                |
| TMAG5273D2QDBVR       | Active        | Production        | SOT-23 (DBV)   6 | 3000   LARGE T&R      | Yes                | SN                            | Level-3-260C-168 HR        | -40 to 125   | 52D2                |
| TMAG5273D2QDBVR.A     | Active        | Production        | SOT-23 (DBV)   6 | 3000   LARGE T&R      | Yes                | SN                            | Level-3-260C-168 HR        | -40 to 125   | 52D2                |

<sup>(1)</sup> **Status:** For more details on status, see our product life cycle.

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.



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## PACKAGE OPTION ADDENDUM

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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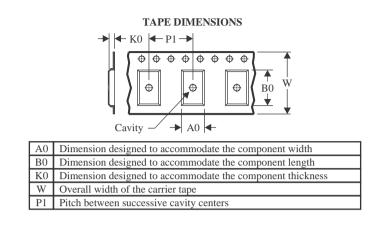


Texas

STRUMENTS

## TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



| *All dimensions are nominal |                 |                    |   |      |                          |                          |            |            |            |            |           |                  |
|-----------------------------|-----------------|--------------------|---|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| Device                      | Package<br>Type | Package<br>Drawing |   | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
| TMAG5273A1QDBVR             | SOT-23          | DBV                | 6 | 3000 | 178.0                    | 9.0                      | 3.3        | 3.2        | 1.4        | 4.0        | 8.0       | Q3               |
| TMAG5273A2QDBVR             | SOT-23          | DBV                | 6 | 3000 | 178.0                    | 9.0                      | 3.3        | 3.2        | 1.4        | 4.0        | 8.0       | Q3               |
| TMAG5273B1QDBVR             | SOT-23          | DBV                | 6 | 3000 | 178.0                    | 9.0                      | 3.3        | 3.2        | 1.4        | 4.0        | 8.0       | Q3               |
| TMAG5273B2QDBVR             | SOT-23          | DBV                | 6 | 3000 | 178.0                    | 9.0                      | 3.3        | 3.2        | 1.4        | 4.0        | 8.0       | Q3               |
| TMAG5273C1QDBVR             | SOT-23          | DBV                | 6 | 3000 | 178.0                    | 9.0                      | 3.3        | 3.2        | 1.4        | 4.0        | 8.0       | Q3               |
| TMAG5273C2QDBVR             | SOT-23          | DBV                | 6 | 3000 | 178.0                    | 9.0                      | 3.3        | 3.2        | 1.4        | 4.0        | 8.0       | Q3               |
| TMAG5273D1QDBVR             | SOT-23          | DBV                | 6 | 3000 | 178.0                    | 9.0                      | 3.3        | 3.2        | 1.4        | 4.0        | 8.0       | Q3               |
| TMAG5273D2QDBVR             | SOT-23          | DBV                | 6 | 3000 | 178.0                    | 9.0                      | 3.3        | 3.2        | 1.4        | 4.0        | 8.0       | Q3               |



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## PACKAGE MATERIALS INFORMATION

25-Sep-2024



| Device          | Device Package Type |     | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |  |  |  |  |
|-----------------|---------------------|-----|------|------|-------------|------------|-------------|--|--|--|--|
| TMAG5273A1QDBVR | SOT-23              | DBV | 6    | 3000 | 190.0       | 190.0      | 30.0        |  |  |  |  |
| TMAG5273A2QDBVR | SOT-23              | DBV | 6    | 3000 | 190.0       | 190.0      | 30.0        |  |  |  |  |
| TMAG5273B1QDBVR | SOT-23              | DBV | 6    | 3000 | 190.0       | 190.0      | 30.0        |  |  |  |  |
| TMAG5273B2QDBVR | SOT-23              | DBV | 6    | 3000 | 190.0       | 190.0      | 30.0        |  |  |  |  |
| TMAG5273C1QDBVR | SOT-23              | DBV | 6    | 3000 | 190.0       | 190.0      | 30.0        |  |  |  |  |
| TMAG5273C2QDBVR | SOT-23              | DBV | 6    | 3000 | 190.0       | 190.0      | 30.0        |  |  |  |  |
| TMAG5273D1QDBVR | SOT-23              | DBV | 6    | 3000 | 190.0       | 190.0      | 30.0        |  |  |  |  |
| TMAG5273D2QDBVR | SOT-23              | DBV | 6    | 3000 | 190.0       | 190.0      | 30.0        |  |  |  |  |

## **DBV0006A**



## **PACKAGE OUTLINE**

## SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.2. This drawing is subject to change without notice.3. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.25 per side.

- 4. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
- 5. Refernce JEDEC MO-178.



## **DBV0006A**

# **EXAMPLE BOARD LAYOUT**

## SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



## **DBV0006A**

## **EXAMPLE STENCIL DESIGN**

## SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



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